

**FEATURES**

- 1.8V power supply
- LVCMOS compatible with multiplexed address
- Four banks operation
- MRS cycle with address key programs
  - CAS Latency (3)
  - Burst Length (1, 2, 4, 8 & full page)
  - Burst Type (Sequential & Interleave)
- EMRS cycle with address
- All inputs are sampled at the positive going edge of the system clock
- Special function support
  - PASR (Partial Array Self Refresh)
  - TCSR (Temperature Compensated Self Refresh)
  - DS (Driver Strength)
- DQM for masking
- Auto & self refresh
- 64ms refresh period (4K cycle)

**ORDERING INFORMATION**

| Product ID        | Max Freq. | Package      | Comments |
|-------------------|-----------|--------------|----------|
| M52D256328A-6BG2F | 166MHz    | 90 Ball FBGA | Pb-free  |
| M52D256328A-7BG2F | 143MHz    | 90 Ball FBGA | Pb-free  |

**GENERAL DESCRIPTION**

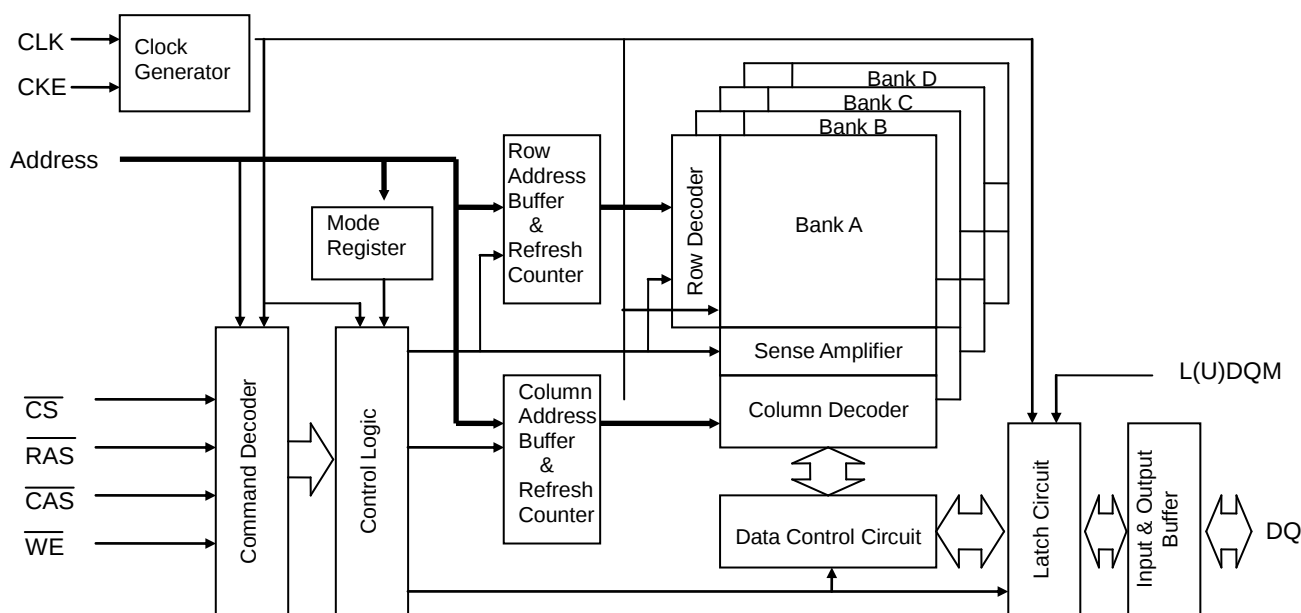
The M52D256328A is 268,435,456 bits synchronous high data rate Dynamic RAM organized as 4 x 2,097,152 words by 32 bits. Synchronous design allows precise cycle controls with the use of system clock I/O transactions are possible on every clock cycle. Range of operating frequencies, programmable burst lengths and programmable latencies allow the same device to be useful for a variety of high bandwidth, high performance memory system applications.

**BALL CONFIGURATION (TOP VIEW)**

(BGA 90, 8mmX13mmX1.2mm Body, 0.8mm Ball Pitch)

|   | 1    | 2    | 3    | 4 | 5 | 6 | 7                       | 8                      | 9                       |
|---|------|------|------|---|---|---|-------------------------|------------------------|-------------------------|
| A | DQ26 | DQ24 | VSS  |   |   |   | VDD                     | DQ23                   | DQ21                    |
| B | DQ28 | VDDQ | VSSQ |   |   |   | VDDQ                    | VSSQ                   | DQ19                    |
| C | VSSQ | DQ27 | DQ25 |   |   |   | DQ22                    | DQ20                   | VDDQ                    |
| D | VSSQ | DQ29 | DQ30 |   |   |   | DQ17                    | DQ18                   | VDDQ                    |
| E | VDDQ | DQ31 | NC   |   |   |   | NC                      | DQ16                   | VSSQ                    |
| F | VSS  | DQM3 | A3   |   |   |   | A2                      | DQM2                   | VDD                     |
| G | A4   | A5   | A6   |   |   |   | A10                     | A0                     | A1                      |
| H | A7   | A8   | NC   |   |   |   | NC                      | BA1                    | A11                     |
| J | CLK  | CKE  | A9   |   |   |   | BA0                     | $\overline{\text{CS}}$ | $\overline{\text{RAS}}$ |
| K | DQM1 | NC   | NC   |   |   |   | $\overline{\text{CAS}}$ | $\overline{\text{WE}}$ | DQM0                    |
| L | VDDQ | DQ8  | VSS  |   |   |   | VDD                     | DQ7                    | VSSQ                    |
| M | VSSQ | DQ10 | DQ9  |   |   |   | DQ6                     | DQ5                    | VDDQ                    |
| N | VSSQ | DQ12 | DQ14 |   |   |   | DQ1                     | DQ3                    | VDDQ                    |
| P | DQ11 | VDDQ | VSSQ |   |   |   | VDDQ                    | VSSQ                   | DQ4                     |
| R | DQ13 | DQ15 | VSS  |   |   |   | VDD                     | DQ0                    | DQ2                     |

## FUNCTIONAL BLOCK DIAGRAM



## BALL FUNCTION DESCRIPTION

| PIN                   | NAME                       | INPUT FUNCTION                                                                                                                                                                 |
|-----------------------|----------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| CLK                   | System Clock               | Active on the positive going edge to sample all inputs                                                                                                                         |
| $\overline{CS}$       | Chip Select                | Disables or enables device operation by masking or enabling all inputs except CLK , CKE and DQM                                                                                |
| CKE                   | Clock Enable               | Masks system clock to freeze operation from the next clock cycle. CKE should be enabled at least one cycle prior new command. Disable input buffers for power down in standby. |
| A0 ~ A11              | Address                    | Row / column address are multiplexed on the same pins.<br>Row address : RA0~RA11, column address : CA0~CA8                                                                     |
| BA0 , BA1             | Bank Select Address        | Selects bank to be activated during row address latch time.<br>Selects bank for read / write during column address latch time.                                                 |
| $\overline{RAS}$      | Row Address Strobe         | Latches row addresses on the positive going edge of the CLK with $\overline{RAS}$ low.<br>Enables row access & precharge.                                                      |
| $\overline{CAS}$      | Column Address Strobe      | Latches column address on the positive going edge of the CLK with $\overline{CAS}$ low.<br>Enables column access.                                                              |
| $\overline{WE}$       | Write Enable               | Enables write operation and row precharge.<br>Latches data in starting from $\overline{CAS}$ , $\overline{WE}$ active.                                                         |
| DQM0 ~ DQM3           | Data Input / Output Mask   | Makes data output Hi-Z, $t_{SHZ}$ after the clock and masks the output. Blocks data input when DQM active.                                                                     |
| DQ0 ~ DQ 31           | Data Input / Output        | Data inputs / outputs are multiplexed on the same pins.                                                                                                                        |
| $V_{DD}$ / $V_{SS}$   | Power Supply / Ground      | Power and ground for the input buffers and the core logic.                                                                                                                     |
| $V_{DDQ}$ / $V_{SSQ}$ | Data Output Power / Ground | Isolated power supply and ground for the output buffers to provide improved noise immunity.                                                                                    |
| NC                    | No Connection              | This pin is recommended to be left No Connection on the device.                                                                                                                |

## ABSOLUTE MAXIMUM RATINGS

| PARAMETER                                                     | SYMBOL                             | VALUE      | UNIT |
|---------------------------------------------------------------|------------------------------------|------------|------|
| Voltage on any pin relative to V <sub>SS</sub>                | V <sub>IN</sub> , V <sub>OUT</sub> | -1.0 ~ 2.6 | V    |
| Voltage on V <sub>DD</sub> supply relative to V <sub>SS</sub> | V <sub>DD</sub> , V <sub>DDQ</sub> | -1.0 ~ 2.6 | V    |
| Operation ambient temperature                                 | T <sub>A</sub>                     | 0 ~ +70    | °C   |
| Storage temperature                                           | T <sub>STG</sub>                   | -55 ~ +150 | °C   |
| Power dissipation                                             | P <sub>D</sub>                     | 1          | W    |
| Short circuit current                                         | I <sub>OS</sub>                    | 50         | mA   |

**Note:** Permanent device damage may occur if ABSOLUTE MAXIMUM RATING are exceeded.  
Functional operation should be restricted to recommended operating condition.  
Exposure to higher than recommended voltage for extended periods of time could affect device reliability.

## DC OPERATING CONDITION

Recommended operating conditions (Voltage referenced to V<sub>SS</sub> = 0V)

| PARAMETER                 | SYMBOL                             | MIN                    | TYP | MAX                   | UNIT | NOTE                     |
|---------------------------|------------------------------------|------------------------|-----|-----------------------|------|--------------------------|
| Supply voltage            | V <sub>DD</sub> , V <sub>DDQ</sub> | 1.7                    | 1.8 | 1.95                  | V    | 1                        |
| Input logic high voltage  | V <sub>IH</sub>                    | 0.8 x V <sub>DDQ</sub> | 1.8 | V <sub>DDQ</sub> +0.3 | V    | 2                        |
| Input logic low voltage   | V <sub>IL</sub>                    | -0.3                   | 0   | 0.3                   | V    | 3                        |
| Output logic high voltage | V <sub>OH</sub>                    | V <sub>DDQ</sub> -0.2  | -   | -                     | V    | I <sub>OH</sub> = -0.1mA |
| Output logic low voltage  | V <sub>OL</sub>                    | -                      | -   | 0.2                   | V    | I <sub>OL</sub> = 0.1mA  |
| Input leakage current     | I <sub>IL</sub>                    | -2                     | -   | 2                     | μA   | 4                        |

**Note:** 1. under all conditions, V<sub>DDQ</sub> must be less than or equal to V<sub>DD</sub>.  
2. V<sub>IH</sub> (max) = 2.2V. The overshoot voltage duration is ≤ 3ns.  
3. V<sub>IL</sub> (min) = -1.0V. The undershoot voltage duration is ≤ 3ns.  
4. Any input 0V ≤ V<sub>IN</sub> ≤ V<sub>DDQ</sub>.  
Input leakage currents include Hi-Z output leakage for all bi-directional buffers with tri-state outputs.

## CAPACITANCE (V<sub>DD</sub> = 1.8V, T<sub>A</sub> = 25 °C, f = 1MHz)

| PARAMETER                                                                                                                                        | SYMBOL           | MIN | MAX | UNIT |
|--------------------------------------------------------------------------------------------------------------------------------------------------|------------------|-----|-----|------|
| Input capacitance (A0 ~ A11, BA0 ~ BA1)                                                                                                          | C <sub>IN1</sub> | 1   | 5   | pF   |
| Input capacitance<br>(CLK, CKE, $\overline{\text{CS}}$ , $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ , $\overline{\text{WE}}$ & DQM0~DQM3) | C <sub>IN2</sub> | 1   | 5   | pF   |
| Data input/output capacitance (DQ0 ~ DQ31)                                                                                                       | C <sub>OUT</sub> | 1   | 6   | pF   |

## DC CHARACTERISTICS

Recommended operating condition unless otherwise noted

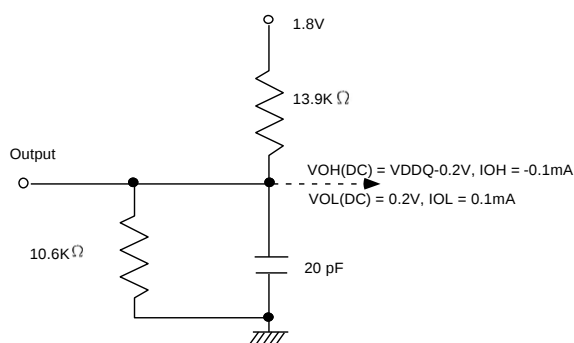
| Parameter                                                                | Symbol             | Test Condition                                                                                                                                                                                      |            | Version |     | Unit | Note |
|--------------------------------------------------------------------------|--------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------|---------|-----|------|------|
|                                                                          |                    |                                                                                                                                                                                                     |            | -6      | -7  |      |      |
| Operating Current<br>(One Bank Active)                                   | I <sub>CC1</sub>   | Burst Length = 1<br>t <sub>RC</sub> ≥ t <sub>RC</sub> (min), t <sub>CC</sub> ≥ t <sub>CC</sub> (min), I <sub>OL</sub> = 0mA                                                                         |            | 70      | 60  | mA   | 1    |
| Precharge Standby<br>Current in power-down<br>mode                       | I <sub>CC2P</sub>  | CKE ≤ V <sub>IL</sub> (max), t <sub>CC</sub> =15ns                                                                                                                                                  |            | 600     |     | uA   |      |
|                                                                          | I <sub>CC2PS</sub> | CKE ≤ V <sub>IL</sub> (max), CLK ≤ V <sub>IL</sub> (max), t <sub>CC</sub> = ∞                                                                                                                       |            | 600     |     | uA   |      |
| Precharge Standby<br>Current in non<br>power-down mode                   | I <sub>CC2N</sub>  | CKE ≥ V <sub>IH</sub> (min), $\overline{CS} \geq V_{IH}(\text{min})$ , t <sub>CC</sub> =10ns<br>Input signals are changed one time during 20ns                                                      |            | 7       |     | mA   |      |
|                                                                          | I <sub>CC2NS</sub> | CKE ≥ V <sub>IH</sub> (min), CLK ≤ V <sub>IL</sub> (max), t <sub>CC</sub> = ∞<br>Input signals are stable                                                                                           |            | 4       |     | mA   |      |
| Active Standby Current<br>in power-down mode                             | I <sub>CC3P</sub>  | CKE ≤ V <sub>IL</sub> (max), t <sub>CC</sub> =15ns                                                                                                                                                  |            | 4       |     | mA   |      |
|                                                                          | I <sub>CC3PS</sub> | CKE ≤ V <sub>IL</sub> (max), CLK ≤ V <sub>IL</sub> (max), t <sub>CC</sub> = ∞                                                                                                                       |            | 4       |     |      |      |
| Active Standby Current<br>in non power-down<br>mode<br>(One Bank Active) | I <sub>CC3N</sub>  | CKE ≥ V <sub>IH</sub> (min), $\overline{CS} \geq V_{IH}(\text{min})$ , t <sub>CC</sub> =15ns<br>Input signals are changed one time during 2clks<br>All other pins ≥ V <sub>DD</sub> -0.2V or ≤ 0.2V |            | 15      |     | mA   |      |
|                                                                          | I <sub>CC3NS</sub> | CKE ≥ V <sub>IH</sub> (min), CLK ≤ V <sub>IL</sub> (max), t <sub>CC</sub> = ∞<br>Input signals are stable                                                                                           |            | 4       |     | mA   |      |
| Operating Current<br>(Burst Mode)                                        | I <sub>CC4</sub>   | I <sub>OL</sub> = 0mA, Page Burst<br>All Bank Activated, t <sub>CCD</sub> = t <sub>CCD</sub> (min)                                                                                                  |            | 90      | 80  | mA   | 1    |
| Refresh Current                                                          | I <sub>CC5</sub>   | t <sub>RFC</sub> ≥ t <sub>RFC</sub> (min)                                                                                                                                                           |            | 110     | 95  | mA   | 2    |
| Self Refresh Current                                                     | I <sub>CC6</sub>   | CKE ≤ 0.2V                                                                                                                                                                                          | TCSR range | 45      | 75  | °C   |      |
|                                                                          |                    |                                                                                                                                                                                                     | Full array | 550     | 600 | uA   |      |
|                                                                          |                    |                                                                                                                                                                                                     | 1/2 array  | 530     | 580 |      |      |
|                                                                          |                    |                                                                                                                                                                                                     | 1/4 array  | 510     | 560 |      |      |
|                                                                          |                    |                                                                                                                                                                                                     | 1/8 array  | 490     | 540 |      |      |
|                                                                          |                    |                                                                                                                                                                                                     | 1/16 array | 470     | 520 |      |      |
| Deep Power Down<br>Current                                               | I <sub>CC7</sub>   | CKE ≤ 0.2V                                                                                                                                                                                          |            | 10      |     | uA   |      |

**Note:** 1.Measured with outputs open. Addresses are changed only one time during t<sub>CC</sub>(min).

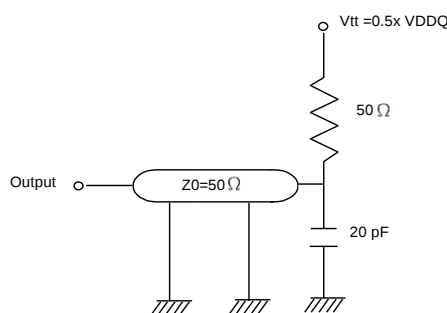
2.Refresh period is 64ms. Addresses are changed only one time during t<sub>CC</sub>(min).

## AC OPERATING TEST CONDITIONS ( $V_{DD} = 1.7V \sim 1.95V$ )

| Parameter                                 | Value                      | Unit |
|-------------------------------------------|----------------------------|------|
| Input levels ( $V_{ih}/V_{il}$ )          | $0.9 \times V_{DDQ} / 0.2$ | V    |
| Input timing measurement reference level  | $0.5 \times V_{DDQ}$       | V    |
| Input rise and fall time                  | $t_r / t_f = 1 / 1$        | ns   |
| Output timing measurement reference level | $0.5 \times V_{DDQ}$       | V    |
| Output load condition                     | See Fig.2                  |      |



(Fig.1) DC Output Load circuit



(Fig.2) AC Output Load Circuit

## OPERATING AC PARAMETER

(AC operating conditions unless otherwise noted)

| Parameter                                          |                | Symbol          | Version |    | Unit | Note |
|----------------------------------------------------|----------------|-----------------|---------|----|------|------|
|                                                    |                |                 | -6      | -7 |      |      |
| Row active to row active delay                     |                | $t_{RRD}(\min)$ | 12      | 14 | ns   | 1    |
| $\overline{RAS}$ to $\overline{CAS}$ delay         |                | $t_{RCD}(\min)$ | 18      | 21 | ns   | 1    |
| Row precharge time                                 |                | $t_{RP}(\min)$  | 18      | 21 | ns   | 1    |
| Row active time                                    |                | $t_{RAS}(\min)$ | 42      | 42 | ns   | 1    |
|                                                    |                | $t_{RAS}(\max)$ | 100     |    | us   | -    |
| Row cycle time                                     | @ Operating    | $t_{RC}(\min)$  | 60      | 63 | ns   | 1    |
|                                                    | @ Auto refresh | $t_{RFC}(\min)$ | 80      |    | ns   | 1, 5 |
| Last data in to new col. Address delay             |                | $t_{CDL}(\min)$ | 1       |    | CLK  | 2    |
| Last data in to row precharge                      |                | $t_{RDL}(\min)$ | 2       |    | CLK  | 2    |
| Last data in to burst stop                         |                | $t_{BDL}(\min)$ | 1       |    | CLK  | 2    |
| Col. Address to col. Address delay                 |                | $t_{CCD}(\min)$ | 1       |    | CLK  | 3    |
| Mode Register command to Active or Refresh Command |                | $t_{MRD}(\min)$ | 2       |    | CLK  | -    |
| Refresh period(4,096 rows)                         |                | $t_{REF}(\max)$ | 64      |    | ms   | 6    |
| Number of valid output data                        |                |                 | 2       |    | ea   | 4    |

- Note:** 1. The minimum number of clock cycles is determined by dividing the minimum time required with clock cycle time and then rounding off to the next higher integer.  
 3. Minimum delay is required to complete write.  
 4. All parts allow every cycle column address change.  
 5. In case of row precharge interrupt, auto precharge and read burst stop.  
 The earliest a precharge command can be issued after a Read command without the loss of data is  $CL+BL-2$  clocks  
 5. A new command may be given  $t_{RFC}$  after self refresh exit.  
 6. A maximum of eight consecutive AUTO REFRESH commands (with  $t_{RFCmin}$ ) can be posted to any given SDRAM, and the maximum absolute interval between any AUTO REFRESH command and the next AUTO REFRESH command is  $8 \times 15.6 \mu s$ .)

## AC CHARACTERISTICS (AC operating conditions unless otherwise noted)

| Parameter                 | Symbol           | -6  |      | -7  |      | Unit | Note |
|---------------------------|------------------|-----|------|-----|------|------|------|
|                           |                  | Min | Max  | Min | Max  |      |      |
| CLK cycle time            | t <sub>CC</sub>  | 6   | 1000 | 7   | 1000 | ns   | 1    |
| CLK to valid output delay | t <sub>SAC</sub> |     | 5.4  |     | 6    | ns   | 1    |
| Output data hold time     | t <sub>OH</sub>  | 2.3 |      | 2.5 |      | ns   | 2    |
| CLK high pulse width      | t <sub>CH</sub>  | 2.5 |      | 2.5 |      | ns   | 3    |
| CLK low pulse width       | t <sub>CL</sub>  | 2.5 |      | 2.5 |      | ns   | 3    |
| Input setup time          | t <sub>SS</sub>  | 2   |      | 2   |      | ns   | 3    |
| Input hold time           | t <sub>SH</sub>  | 1   |      | 1.5 |      | ns   | 3    |
| CLK to output in Low-Z    | t <sub>SLZ</sub> | 1   |      | 1   |      | ns   | 2    |
| CLK to output in Hi-Z     | t <sub>SHZ</sub> |     | 5.4  |     | 6    | ns   |      |

\*All AC parameters are measured from half to half.

**Note:** 1. Parameters depend on programmed CAS latency.

2. If clock rising time is longer than 1ns, (tr/2-0.5)ns should be added to the parameter.

3. Assumed input rise and fall time (tr & tf)=1ns.

If tr & tf is longer than 1ns, transient time compensation should be considered, i.e., [(tr+ tf)/2-1]ns should be added to the parameter.

## SIMPLIFIED TRUTH TABLE

| COMMAND                                 |                            |       | CKEn-1 | CKEn | $\overline{CS}$ | $\overline{RAS}$ | $\overline{CAS}$ | $\overline{WE}$ | DQM | BA0<br>BA1 | A10/AP      | A11,<br>A9~A0          | Note |
|-----------------------------------------|----------------------------|-------|--------|------|-----------------|------------------|------------------|-----------------|-----|------------|-------------|------------------------|------|
| Register                                | Mode Register set          |       | H      | X    | L               | L                | L                | L               | X   | OP CODE    |             |                        | 1,2  |
|                                         | Extended Mode Register set |       |        |      |                 |                  |                  |                 |     |            |             |                        |      |
| Refresh                                 | Auto Refresh               |       | H      | H    | L               | L                | L                | H               | X   | X          |             |                        | 3    |
|                                         | Self Refresh               | Entry |        | L    |                 |                  |                  |                 |     |            |             |                        | 3    |
|                                         |                            | Exit  | L      | H    | L               | H                | H                | H               | X   | X          |             |                        | 3    |
|                                         |                            |       |        |      | H               | X                | X                | X               | X   |            |             |                        | 3    |
| Bank Active & Row Addr.                 |                            |       | H      | X    | L               | L                | H                | H               | X   | V          | Row Address |                        |      |
| Read & Column Address                   | Auto Precharge Disable     |       | H      | X    | L               | H                | L                | H               | X   | V          | L           | Column Address (A0~A8) | 4    |
|                                         | Auto Precharge Enable      |       |        |      |                 |                  |                  |                 |     |            | H           |                        | 4,5  |
| Write & Column Address                  | Auto Precharge Disable     |       | H      | X    | L               | H                | L                | L               | X   | V          | L           | Column Address (A0~A8) | 4    |
|                                         | Auto Precharge Enable      |       |        |      |                 |                  |                  |                 |     |            | H           |                        | 4,5  |
| Burst Stop                              |                            |       | H      | X    | L               | H                | H                | L               | X   | X          |             |                        | 6    |
| Precharge                               | Bank Selection             |       | H      | X    | L               | L                | H                | L               | X   | V          | L           | X                      |      |
|                                         | All Banks                  |       |        |      |                 |                  |                  |                 |     | X          | H           |                        |      |
| Clock Suspend or Active Power Down Mode |                            | Entry | H      | L    | H               | X                | X                | X               | X   | X          |             |                        |      |
|                                         |                            |       |        |      | L               | H                | H                | H               |     |            |             |                        |      |
|                                         |                            | Exit  | L      | H    | X               | X                | X                | X               | X   |            |             |                        |      |
| Precharge Power Down Mode               |                            | Entry | H      | L    | H               | X                | X                | X               | X   | X          |             |                        |      |
|                                         |                            |       |        |      | L               | H                | H                | H               |     |            |             |                        |      |
|                                         |                            | Exit  | L      | H    | H               | X                | X                | X               | X   |            |             |                        |      |
|                                         |                            |       |        |      | L               | H                | H                | H               |     |            |             |                        |      |
| DQM                                     |                            |       | H      | X    |                 |                  |                  |                 | V   | X          |             | 7                      |      |
| No Operating Command                    |                            |       | H      | X    | H               | X                | X                | X               | X   | X          |             |                        |      |
|                                         |                            |       |        |      | L               | H                | H                | H               |     |            |             |                        |      |
| Deep Power Down Mode                    |                            | Entry | H      | L    | L               | H                | H                | L               | X   | X          |             |                        |      |
|                                         |                            | Exit  | L      | H    | X               | X                | X                | X               | X   |            |             |                        |      |

(V = Valid, X = Don't Care. H = Logic High, L = Logic Low)

- Note:
- 1.OP Code: Operating Code  
A0~A11 & BA0~BA1: Program keys. (@ MRS). BA1=0 for MRS and BA1=1 for EMRS
  - 2.MRS/EMRS can be issued only at all banks precharge state.  
A new command can be issued after 2 CLK cycles of MRS/EMRS.
  - 3.Auto refresh functions are as same as CBR refresh of DRAM.  
The automatical precharge without row precharge of command is meant by "Auto".  
Auto/self refresh can be issued only at all banks idle state.
  - 4.BA0~BA1: Bank select addresses.  
If both BA0 and BA1 are "Low" at read, write, row active and precharge, bank A is selected.  
If both BA0 is "Low" and BA1 is "High" at read, write, row active and precharge, bank B is selected.  
If both BA0 is "High" and BA1 is "Low" at read, write, row active and precharge, bank C is selected.  
If both BA0 and BA1 are "High" at read, write, row active and precharge, bank D is selected  
If A10/AP is "High" at row precharge, BA0 and BA1 is ignored and all banks are selected.
  - 5.During burst read or write with auto precharge, new read/write command can not be issued.  
Another bank read/write command can be issued after the end of burst.  
New row active of the associated bank can be issued at  $t_{RP}$  after the end of burst.
  - 6.Burst stop command is valid at every burst length.
  - 7.DQM sampled at positive going edge of a CLK and masks the data-in at the very CLK (write DQM latency is 0), but makes Hi-Z state the data-out of 2 CLK cycles after.(Read DQM latency is 2)

## MODE REGISTER FIELD TABLE TO PROGRAM MODES

Register Programmed with MRS

| Address  | BA0 | BA1 | A11~A10/AP | A9    | A8~A7 | A6          | A5 | A4 | A3 | A2           | A1 | A0 |
|----------|-----|-----|------------|-------|-------|-------------|----|----|----|--------------|----|----|
| Function | 0   | 0   | RFU        | W.B.L | TM    | CAS Latency |    |    | BT | Burst Length |    |    |

| Test Mode          |            |                   | CAS Latency |    |    |          | Burst Type |            | Burst Length |    |    |           |          |
|--------------------|------------|-------------------|-------------|----|----|----------|------------|------------|--------------|----|----|-----------|----------|
| A8                 | A7         | Type              | A6          | A5 | A4 | Latency  | A3         | Type       | A2           | A1 | A0 | BT = 0    | BT = 1   |
| 0                  | 0          | Mode Register Set | 0           | 0  | 0  | Reserved | 0          | Sequential | 0            | 0  | 0  | 1         | 1        |
| 0                  | 1          | Reserved          | 0           | 0  | 1  | Reserved | 1          | Interleave | 0            | 0  | 1  | 2         | 2        |
| 1                  | 0          | EMRS              | 0           | 1  | 0  | Reserved |            |            | 0            | 1  | 0  | 4         | 4        |
| 1                  | 1          | Reserved          | 0           | 1  | 1  | 3        |            |            | 0            | 1  | 1  | 8         | 8        |
| Write Burst Length |            |                   | 1           | 0  | 0  | Reserved |            |            | 1            | 0  | 0  | Reserved  | Reserved |
| A9                 | Length     |                   | 1           | 0  | 1  | Reserved |            |            | 1            | 0  | 1  | Reserved  | Reserved |
| 0                  | Burst      |                   | 1           | 1  | 0  | Reserved |            |            | 1            | 1  | 0  | Reserved  | Reserved |
| 1                  | Single Bit |                   | 1           | 1  | 1  | Reserved |            |            | 1            | 1  | 1  | Full Page | Reserved |

Full Page Length: 512

Note:

1. RFU (Reserved for future use) should stay "0" during MRS cycle.
2. If A9 is high during MRS cycle, "Burst Read Single Bit Write" function will be enabled.
3. The full column burst (512 bit) is available only at sequential mode of burst type.

## EXTENDED MODE REGISTER SET (EMRS)

The extended mode register stores for selecting PASR; DS. The extended mode register set must be done before any active command after the power up sequence. The extended mode register is written by asserting low on  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$ ,  $\overline{WE}$  and high on BA1, low on BA0 (The SDRAM should be in all bank precharge with CKE already high prior to writing into the extended mode register). The state of address pins

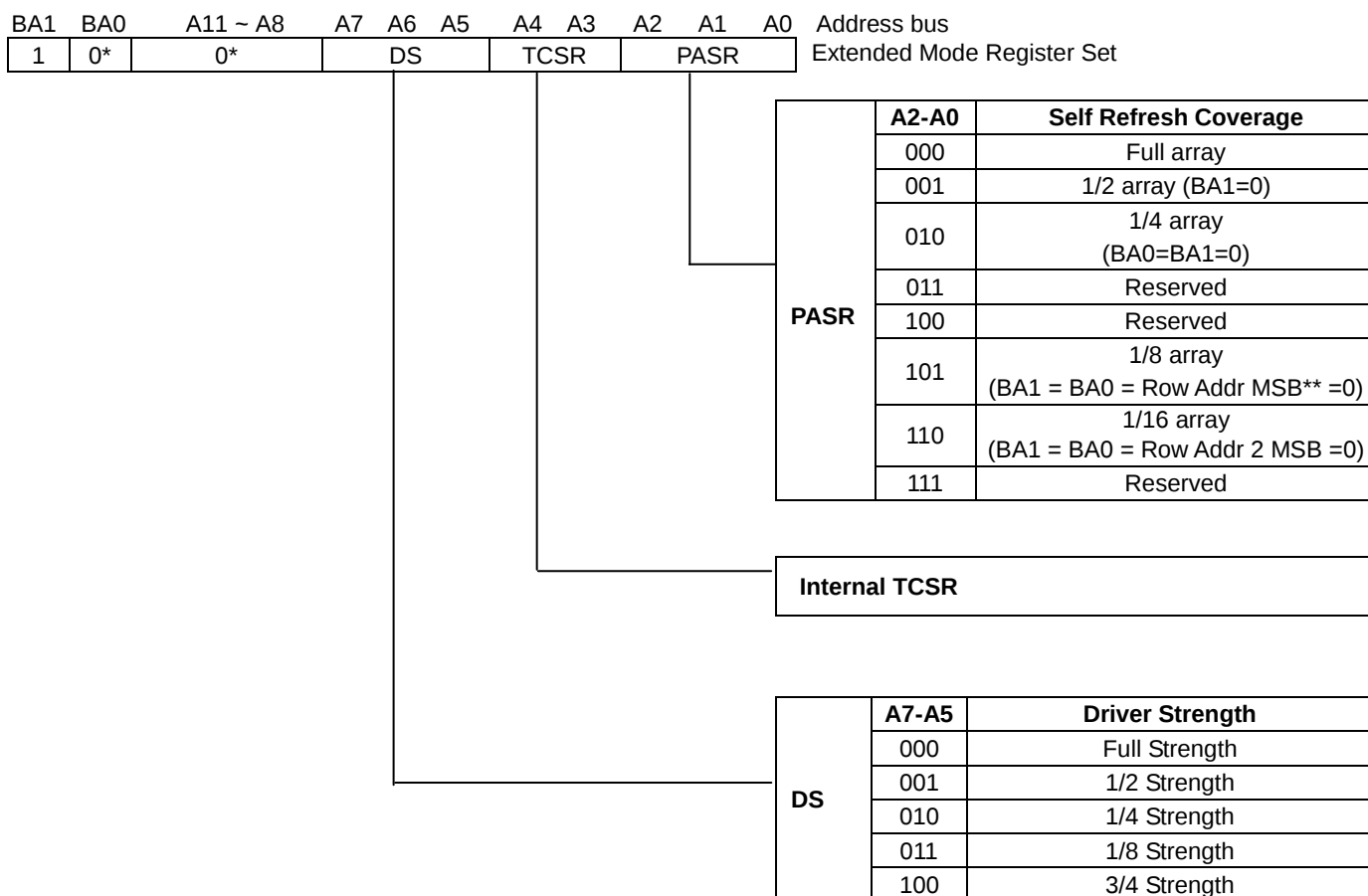
A0~An in the same cycle as  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$ ,  $\overline{WE}$  going low is written in the extended mode register. Refer to the table for specific codes.

The extended mode register can be changed by using the same command and clock cycle requirements during operations as long as all banks are in the idle state.

## Internal Temperature Compensated Self Refresh (TCSR)

Note:

1. In order to save power consumption, Mobile-DRAM includes the internal temperature sensor and control units to control the self refresh cycle automatically according to the device temperature.
2. If the EMRS for external TCSR is issued by the controller, this EMRS code for TCSR is ignored.



Note: \* BA0 and A11~ A8 should stay "0" during EMRS cycle

\*\* MSB: most significant bit

**BURST SEQUENCE (BURST LENGTH = 4)**

| Initial Address |    | Sequential |   |   |   | Interleave |   |   |   |
|-----------------|----|------------|---|---|---|------------|---|---|---|
| A1              | A0 |            |   |   |   |            |   |   |   |
| 0               | 0  | 0          | 1 | 2 | 3 | 0          | 1 | 2 | 3 |
| 0               | 1  | 1          | 2 | 3 | 0 | 1          | 0 | 3 | 2 |
| 1               | 0  | 2          | 3 | 0 | 1 | 2          | 3 | 0 | 1 |
| 1               | 1  | 3          | 0 | 1 | 2 | 3          | 2 | 1 | 0 |

**BURST SEQUENCE (BURST LENGTH = 8)**

| Initial Address |    |    | Sequential |   |   |   |   |   |   |   | Interleave |   |   |   |   |   |   |   |
|-----------------|----|----|------------|---|---|---|---|---|---|---|------------|---|---|---|---|---|---|---|
| A2              | A1 | A0 |            |   |   |   |   |   |   |   |            |   |   |   |   |   |   |   |
| 0               | 0  | 0  | 0          | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 0          | 1 | 2 | 3 | 4 | 5 | 6 | 7 |
| 0               | 0  | 1  | 1          | 2 | 3 | 4 | 5 | 6 | 7 | 0 | 1          | 0 | 3 | 2 | 5 | 4 | 7 | 6 |
| 0               | 1  | 0  | 2          | 3 | 4 | 5 | 6 | 7 | 0 | 1 | 2          | 3 | 0 | 1 | 6 | 7 | 4 | 5 |
| 0               | 1  | 1  | 3          | 4 | 5 | 6 | 7 | 0 | 1 | 2 | 3          | 2 | 1 | 0 | 7 | 6 | 5 | 4 |
| 1               | 0  | 0  | 4          | 5 | 6 | 7 | 0 | 1 | 2 | 3 | 4          | 5 | 6 | 7 | 0 | 1 | 2 | 3 |
| 1               | 0  | 1  | 5          | 6 | 7 | 0 | 1 | 2 | 3 | 4 | 5          | 4 | 7 | 6 | 1 | 0 | 3 | 2 |
| 1               | 1  | 0  | 6          | 7 | 0 | 1 | 2 | 3 | 4 | 5 | 6          | 7 | 4 | 5 | 2 | 3 | 0 | 1 |
| 1               | 1  | 1  | 7          | 0 | 1 | 2 | 3 | 4 | 5 | 6 | 7          | 6 | 5 | 4 | 3 | 2 | 1 | 0 |

## DEVICE OPERATIONS

### CLOCK (CLK)

The clock input is used as the reference for all SDRAM operations. All operations are synchronized to the positive going edge of the clock. The clock transitions must be monotonic between  $V_{IL}$  and  $V_{IH}$ . During operation with  $\overline{CKE}$  high all inputs are assumed to be in valid state (low or high) for the duration of setup and hold time around positive edge of the clock for proper functionality and Icc specifications.

### CLOCK ENABLE(CKE)

The clock enable (CKE) gates the clock onto SDRAM. If  $\overline{CKE}$  goes low synchronously with clock (set-up and hold time same as other inputs), the internal clock suspended from the next clock cycle and the state of output and burst address is frozen as long as the  $\overline{CKE}$  remains low. All other inputs are ignored from the next clock cycle after  $\overline{CKE}$  goes low. When all banks are in the idle state and  $\overline{CKE}$  goes low synchronously with clock, the SDRAM enters the power down mode from the next clock cycle. The SDRAM remains in the power down mode ignoring the other inputs as long as  $\overline{CKE}$  remains low. The power down exit is synchronous as the internal clock is suspended. When  $\overline{CKE}$  goes high at least "1CLK + tss" before the high going edge of the clock, then the SDRAM becomes active from the same clock edge accepting all the input commands.

### BANK ADDRESSES (BA0~BA1)

This SDRAM is organized as four independent banks of 2,097,152 words x 32 bits memory arrays. The BA0~BA1 inputs are latched at the time of assertion of  $\overline{RAS}$  and  $\overline{CAS}$  to select the bank to be used for the operation. The banks addressed BA0~BA1 are latched at bank active, read, write, mode register set and precharge operations.

### ADDRESS INPUTS (A0~A11)

The 21 address bits are required to decode the 2,097,152 word locations are multiplexed into 12 address input pins (A0~A11). The 12 row addresses are latched along with  $\overline{RAS}$  and BA0~BA1 during bank active command. The 9 bit column addresses are latched along with  $\overline{CAS}$ ,  $\overline{WE}$  and BA0~BA1 during read or with command.

### NOP and DEVICE DESELECT

When  $\overline{RAS}$ ,  $\overline{CAS}$  and  $\overline{WE}$  are high, The SDRAM performs no operation (NOP). NOP does not initiate any new operation, but is needed to complete operations which require more than single clock cycle like bank activate, burst read, auto refresh, etc. The device deselect is also a NOP and is entered by asserting  $\overline{CS}$  high.  $\overline{CS}$  high disables the command decoder so that  $\overline{RAS}$ ,  $\overline{CAS}$ ,  $\overline{WE}$  and all the address inputs are ignored.

### MODE REGISTER SET (MRS)

The mode register stores the data for controlling the various operating modes of SDRAM. It programs the CAS latency, burst type, burst length, test mode and various vendor specific options to make SDRAM useful for variety of different applications. The default value of the mode register is not defined, therefore the mode register must be written after power up to operate the SDRAM. The mode register is written by asserting low on  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$  and  $\overline{WE}$  (The SDRAM should be in active mode with  $\overline{CKE}$  already high prior to writing the mode register). The state of address pins A0~A11 and BA0~BA1 in the same cycle as  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$  and  $\overline{WE}$  going low is the data written in the mode register. Two clock cycles is required to complete the write in the mode register. The mode register contents can be changed using the same command and clock cycle requirements during operation as long as all banks are in the idle state. The mode register is divided into various fields into depending on functionality. The burst length field uses A0~A2, burst type uses A3, CAS latency (read latency from column address) use A4~A6, vendor specific options or test mode use A7~A8, A10~A11 and BA1~BA0. The write burst length is programmed using A9. A7~A8, A10/AP~A11 and BA0~BA1 must be set to low for normal SDRAM operation. Refer to the table for specific codes for various burst length, burst type and CAS latencies.

**DEVICE OPERATIONS (Continued)****BANK ACTIVATE**

The bank activate command is used to select a random row in an idle bank. By asserting low on  $\overline{\text{RAS}}$  and  $\overline{\text{CS}}$  with desired row and bank address, a row access is initiated. The read or write operation can occur after a time delay of  $t_{\text{RCD}}$  (min) from the time of bank activation.  $t_{\text{RCD}}$  is the internal timing parameter of SDRAM, therefore it is dependent on operating clock frequency. The minimum number of clock cycles required between bank activate and read or write command should be calculated by dividing  $t_{\text{RCD}}$  (min) with cycle time of the clock and then rounding of the result to the next higher integer. The SDRAM has four internal banks in the same chip and shares part of the internal circuitry to reduce chip area, therefore it restricts the activation of four banks simultaneously. Also the noise generated during sensing of each bank of SDRAM is high requiring some time for power supplies to recover before another bank can be sensed reliably.  $t_{\text{RRD}}$  (min) specifies the minimum time required between activating different bank. The number of clock cycles required between different bank activation must be calculated similar to  $t_{\text{RCD}}$  specification. The minimum time required for the bank to be active to initiate sensing and restoring the complete row of dynamic cells is determined by  $t_{\text{RAS}}$  (min). Every SDRAM bank activate command must satisfy  $t_{\text{RAS}}$  (min) specification before a precharge command to that active bank can be asserted. The maximum time any bank can be in the active state is determined by  $t_{\text{RAS}}$  (max) and  $t_{\text{RAS}}$  (max) can be calculated similar to  $t_{\text{RCD}}$  specification.

**BURST READ**

The burst read command is used to access burst of data on consecutive clock cycles from an active row in an active bank. The burst read command is issued by asserting low on  $\overline{\text{CS}}$  and  $\overline{\text{RAS}}$  with  $\overline{\text{WE}}$  being high on the positive edge of the clock. The bank must be active for at least  $t_{\text{RCD}}$  (min) before the burst read command is issued. The first output appears in CAS latency number of clock cycles after the issue of burst read command. The burst length, burst sequence and latency from the burst read command is determined by the mode register which is already programmed. The burst read can be initiated on any column address of the active row. The address wraps around if the initial address does not start from a boundary such that number of outputs from each I/O are equal to the burst length programmed in the mode register. The output goes into high-impedance at the end of burst, unless a new burst read was initiated to keep the data output gapless. The burst read can be terminated by issuing another burst read or burst write in the same bank or the other active bank or a precharge command to the same bank. The burst stop command is valid at every page burst length.

**BURST WRITE**

The burst write command is similar to burst read command and is used to write data into the SDRAM on consecutive clock cycles in adjacent addresses depending on burst length and burst sequence. By asserting low on  $\overline{\text{CS}}$ ,  $\overline{\text{CAS}}$

and  $\overline{\text{WE}}$  with valid column address, a write burst is initiated. The data inputs are provided for the initial address in the same clock cycle as the burst write command. The input buffer is deselected at the end of the burst length, even though the internal writing can be completed yet. The writing can be complete by issuing a burst read and DQM for blocking data inputs or burst write in the same or another active bank. The burst stop command is valid at every burst length. The write burst can also be terminated by using DQM for blocking data and precharging the bank  $t_{\text{RDL}}$  after the last data input to be written into the active row. See DQM OPERATION also.

**DQM OPERATION**

The DQM is used mask input and output operations. It works similar to  $\overline{\text{OE}}$  during operation and inhibits writing during write operation. The read latency is two cycles from DQM and zero cycle for write, which means DQM masking occurs two cycles later in read cycle and occurs in the same cycle during write cycle. DQM operation is synchronous with the clock. The DQM signal is important during burst interrupts of write with read or precharge in the SDRAM. Due to asynchronous nature of the internal write, the DQM operation is critical to avoid unwanted or incomplete writes when the complete burst write is required. Please refer to DQM timing diagram also.

**PRECHARGE**

The precharge is performed on an active bank by asserting low on clock cycles required between bank activate and clock cycles required between bank activate and  $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$ ,  $\overline{\text{WE}}$  and A10/AP with valid BA0~BA1 of the bank to be precharged. The precharge command can be asserted anytime after  $t_{\text{RAS}}$  (min) is satisfied from the bank active command in the desired bank.  $t_{\text{RP}}$  is defined as the minimum number of clock cycles required to complete row precharge is calculated by dividing  $t_{\text{RP}}$  with clock cycle time and rounding up to the next higher integer. Care should be taken to make sure that burst write is completed or DQM is used to inhibit writing before precharge command is asserted. The maximum time any bank can be active is specified by  $t_{\text{RAS}}$  (max). Therefore, each bank activates command. At the end of precharge, the bank enters the idle state and is ready to be activated again. Entry to power-down, Auto refresh, Self refresh and Mode register set etc. is possible only when all banks are in idle state.

**DEVICE OPERATIONS (Continued)****AUTO PRECHARGE**

The precharge operation can also be performed by using auto precharge. The SDRAM internally generates the timing to satisfy  $t_{RAS}$  (min) and " $t_{RP}$ " for the programmed burst length and CAS latency. The auto precharge command is issued at the same time as burst write by asserting high on A10/AP, the bank is precharge command is asserted. Once auto precharge command is given, no new commands are possible to that particular bank until the bank achieves idle state.

**ALL BANKS PRECHARGE**

A11 banks can be precharged at the same time by using Precharge all command. Asserting low on  $\overline{CS}$ ,  $\overline{RAS}$ , and  $\overline{WE}$  with high on A10/AP after all banks have satisfied  $t_{RAS}$  (min) requirement, performs precharge on all banks. At the end of  $t_{RP}$  after performing precharge all, all banks are in idle state.

**AUTO REFRESH**

The storage cells of SDRAM need to be refreshed every 64ms to maintain data. An auto refresh cycle accomplishes refresh of a single row of storage cells. The internal counter increments automatically on every auto refresh cycle to refresh all the rows. An auto refresh command is issued by asserting low on  $\overline{CS}$ ,  $\overline{RAS}$  and  $\overline{CAS}$  with high on CKE and  $\overline{WE}$ . The auto refresh command can only be asserted with all banks being in idle state and the device is not in power down mode (CKE is high in the previous cycle). The time required to complete the auto refresh operation is specified by  $t_{RFC}$  (min). The minimum number of clock cycles required can be calculated by driving  $t_{RFC}$  with clock cycle time and then rounding up to the next higher integer. The auto refresh command must be followed by NOP's until the auto refresh operation is completed. The auto refresh is the preferred refresh mode when the SDRAM is being used for normal data transactions. The auto refresh cycle can be performed once in 15.6us.

**SELF REFRESH**

The self refresh is another refresh mode available in the SDRAM. The self refresh is the preferred refresh mode for data retention and low power operation of SDRAM. In self refresh mode, the SDRAM disables the internal clock and all the input buffers except CKE. The refresh addressing and timing is internally generated to reduce power consumption. The self refresh mode is entered from all banks idle state by asserting low on  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$  and CKE with high on  $\overline{WE}$ . Once the self refresh mode is entered, only CKE state being low matters, all the other inputs including clock are ignored to remain in the refresh.

The self refresh is exited by restarting the external clock and then asserting high on CKE. This must be followed by NOP's for a minimum time of  $t_{RFC}$  before the SDRAM reaches idle state to begin normal operation. 4K cycles of burst auto refresh is required immediately before self refresh entry and immediately after self refresh exit.

## COMMANDS

### Mode register set command

( $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$ ,  $\overline{\text{WE}}$ , BA1, BA0 = Low)

The DRAM has a mode register that defines how the device operates. In this command, A0 through BA0 are the data input pins. After power on, the mode register set command must be executed to initialize the device. The mode register can be set only when all banks are in idle state. During 2CLK ( $t_{\text{MRD}}$ ) following this command, the DRAM cannot accept any other commands.

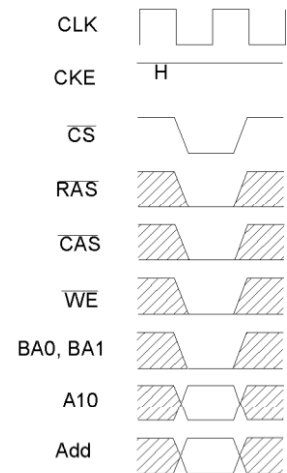


Fig. 1 Mode register set command

### Extended Mode register set command

( $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$ ,  $\overline{\text{WE}}$ , BA0 = Low ; BA1= High)

The DRAM has an extended mode register that defines how to set PASR, DS.

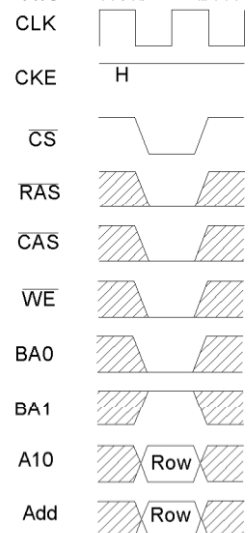


Fig. 2 Extended Mode register set command

### Activate command

( $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$  = Low,  $\overline{\text{CAS}}$ ,  $\overline{\text{WE}}$  = High)

The DRAM has four banks, each with 4,096 rows. This command activates the bank selected by BA1 and BA0 (BS) and a row address selected by A0 through A11.

This command corresponds to a conventional DRAM's  $\overline{\text{RAS}}$  falling.

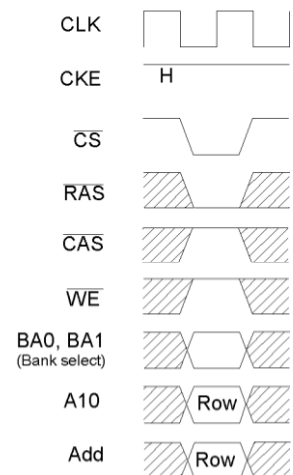


Fig. 3 Row address strobe and bank active command

## Precharge command

( $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$ ,  $\overline{\text{WE}}$  = Low,  $\overline{\text{CAS}}$  = High)

This command begins precharge operation of the bank selected by BA1 and BA0 (BS). When A10 is High, all banks are precharged, regardless of BA1 and BA0. When A10 is Low, only the bank selected by BA1 and BA0 is precharged.

After this command, the DRAM can't accept the activate command to the precharging bank during  $\text{trp}$  (precharge to activate command period).

This command corresponds to a conventional DRAM's  $\overline{\text{RAS}}$  rising.

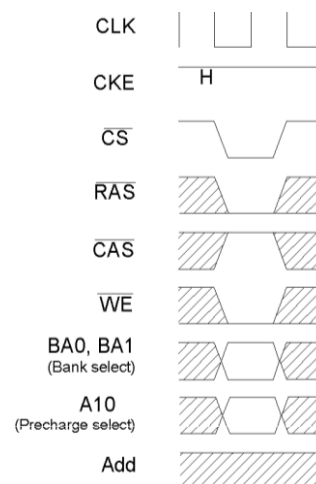


Fig. 4 Precharge command

## Write command

( $\overline{\text{CS}}$ ,  $\overline{\text{CAS}}$ ,  $\overline{\text{WE}}$  = Low,  $\overline{\text{RAS}}$  = High)

If the mode register is in the burst write mode, this command sets the burst start address given by the column address to begin the burst write operation. The first write data in burst can be input with this command with subsequent data on following clocks.

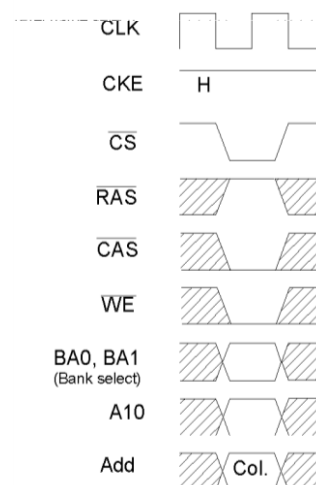


Fig. 5 Column address and write command

## Read command

( $\overline{\text{CS}}$ ,  $\overline{\text{CAS}}$  = Low,  $\overline{\text{RAS}}$ ,  $\overline{\text{WE}}$  = High)

Read data is available after  $\overline{\text{CAS}}$  latency requirements have been met. This command sets the burst start address given by the column address.

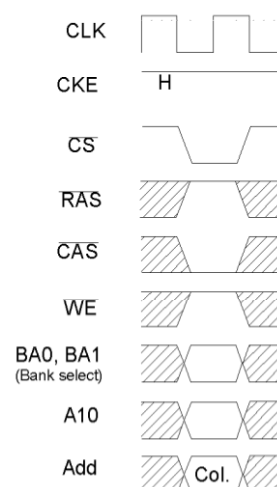


Fig. 6 Column address and read command

## CBR (auto) refresh command

( $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$  = Low,  $\overline{\text{WE}}$ , CKE = High)

This command is a request to begin the CBR refresh operation. The refresh address is generated internally.

Before executing CBR refresh, all banks must be precharged.

After this cycle, all banks will be in the idle (precharged) state and ready for a row activate command.

During  $t_{\text{RFC}}$  period (from refresh command to refresh or activate command), the DRAM cannot accept any other command.

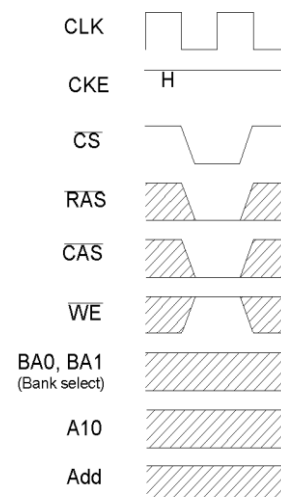


Fig. 7 Auto refresh command

## Self refresh entry command

( $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$ , CKE = Low,  $\overline{\text{WE}}$  = High)

After the command execution, self refresh operation continues while CKE remains low.

When CKE goes to high, the DRAM exits the self refresh mode.

During self refresh mode, refresh interval and refresh operation are performed internally, so there is no need for external control.

Before executing self refresh, all banks must be precharged.

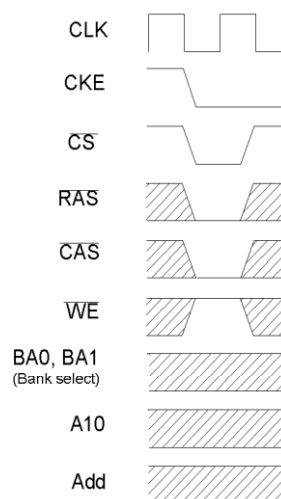


Fig. 8 Self refresh entry command

## Burst stop command

( $\overline{\text{CS}}$ ,  $\overline{\text{WE}}$  = Low,  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$  = High)

This command terminates the current burst operation.

Burst stop is valid at every burst length.

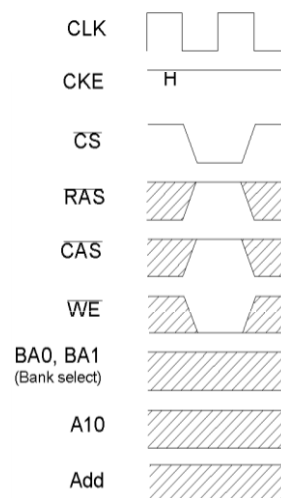


Fig. 9 Burst stop command

## No operation

( $\overline{\text{CS}}$  = Low,  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$ ,  $\overline{\text{WE}}$  = High)

This command is not an execution command. No operations begin or terminate by this command.

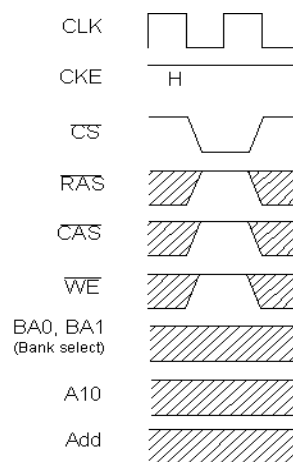
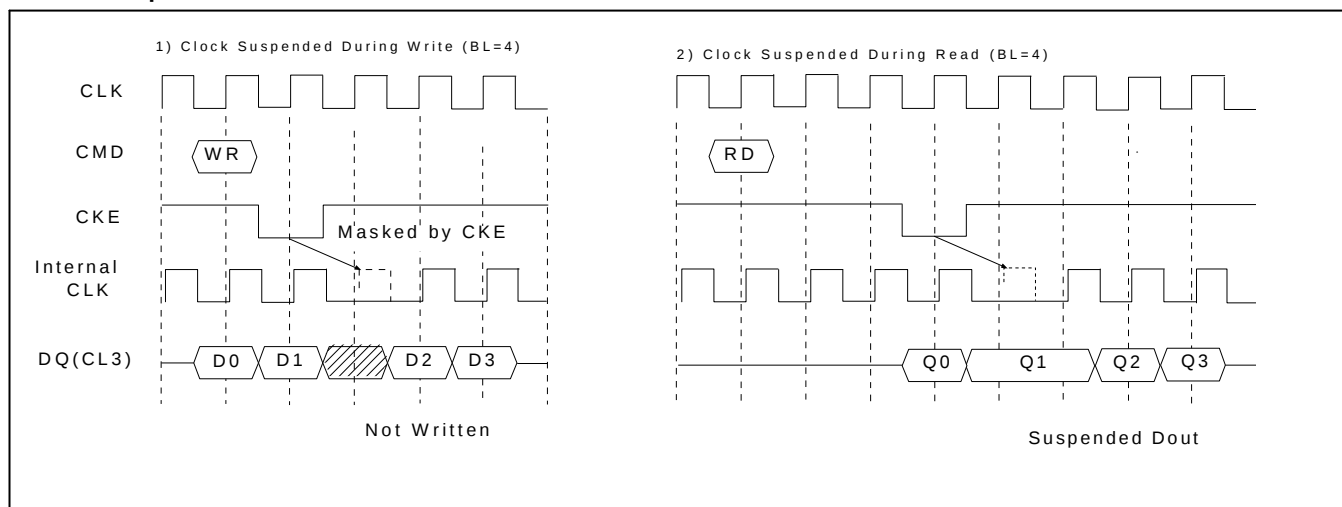


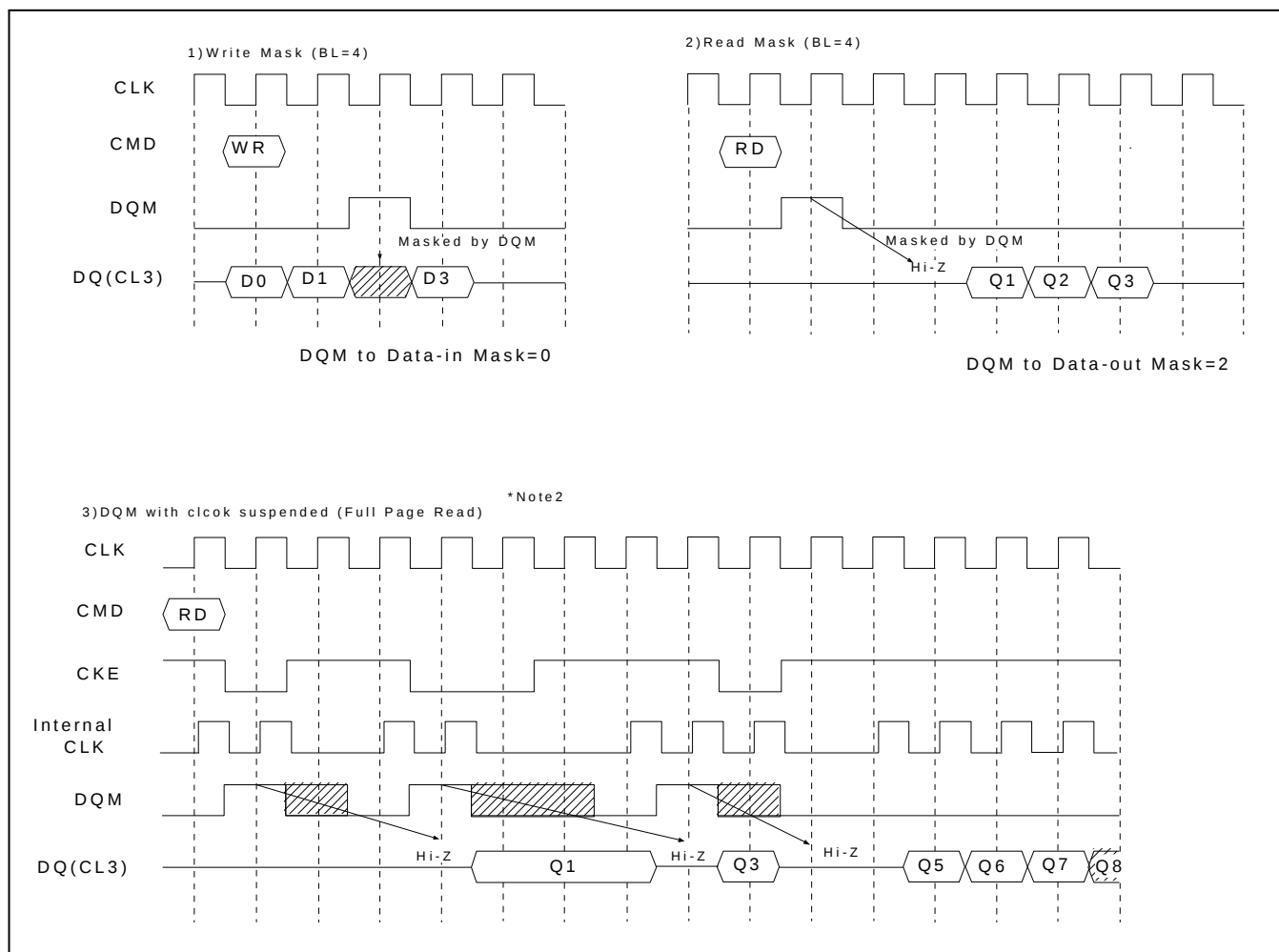
Fig. 10 No operation

## BASIC FEATURE AND FUNCTION DESCRIPTIONS

### 1. CLOCK Suspend

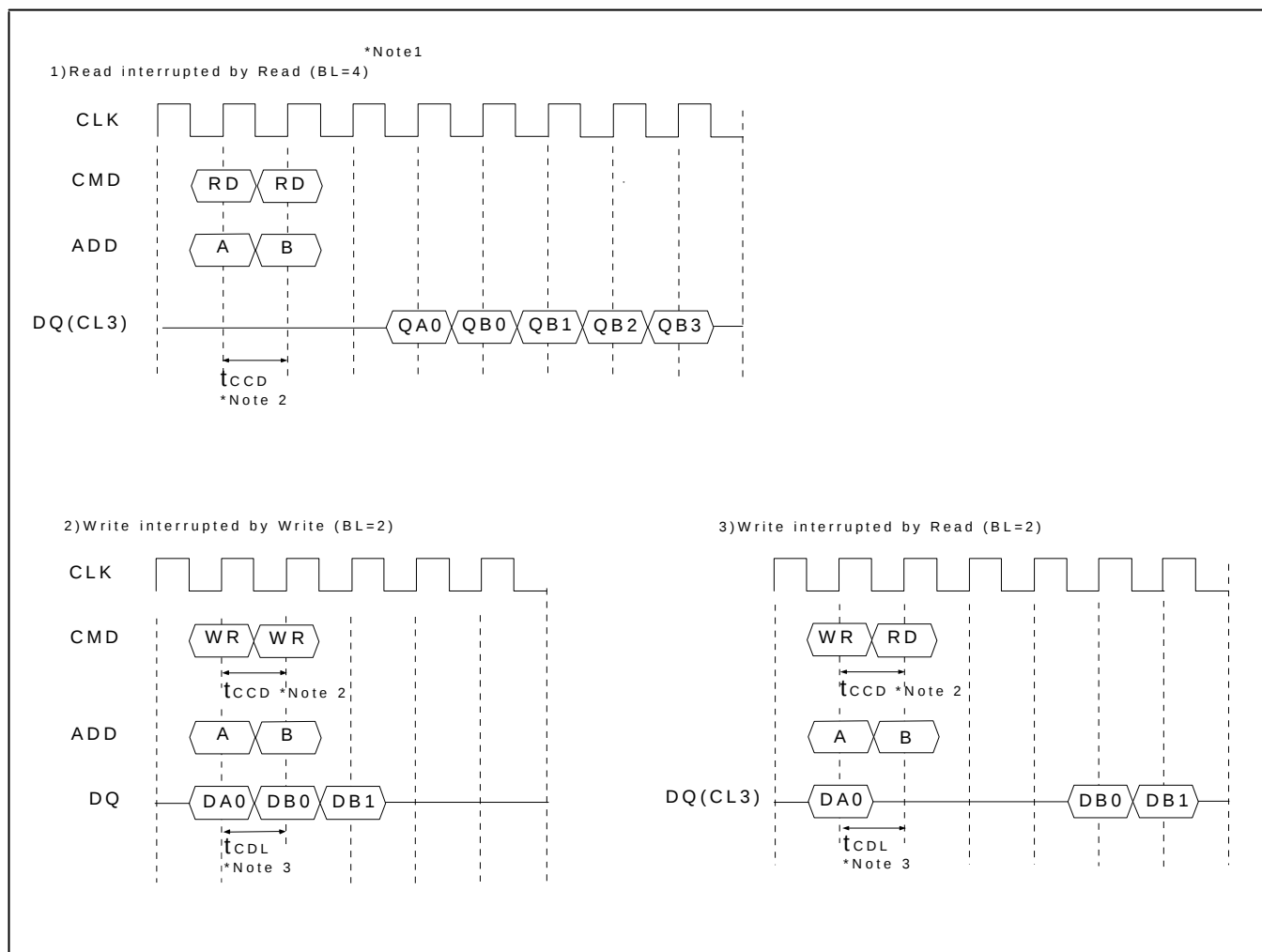


### 2. DQM Operation



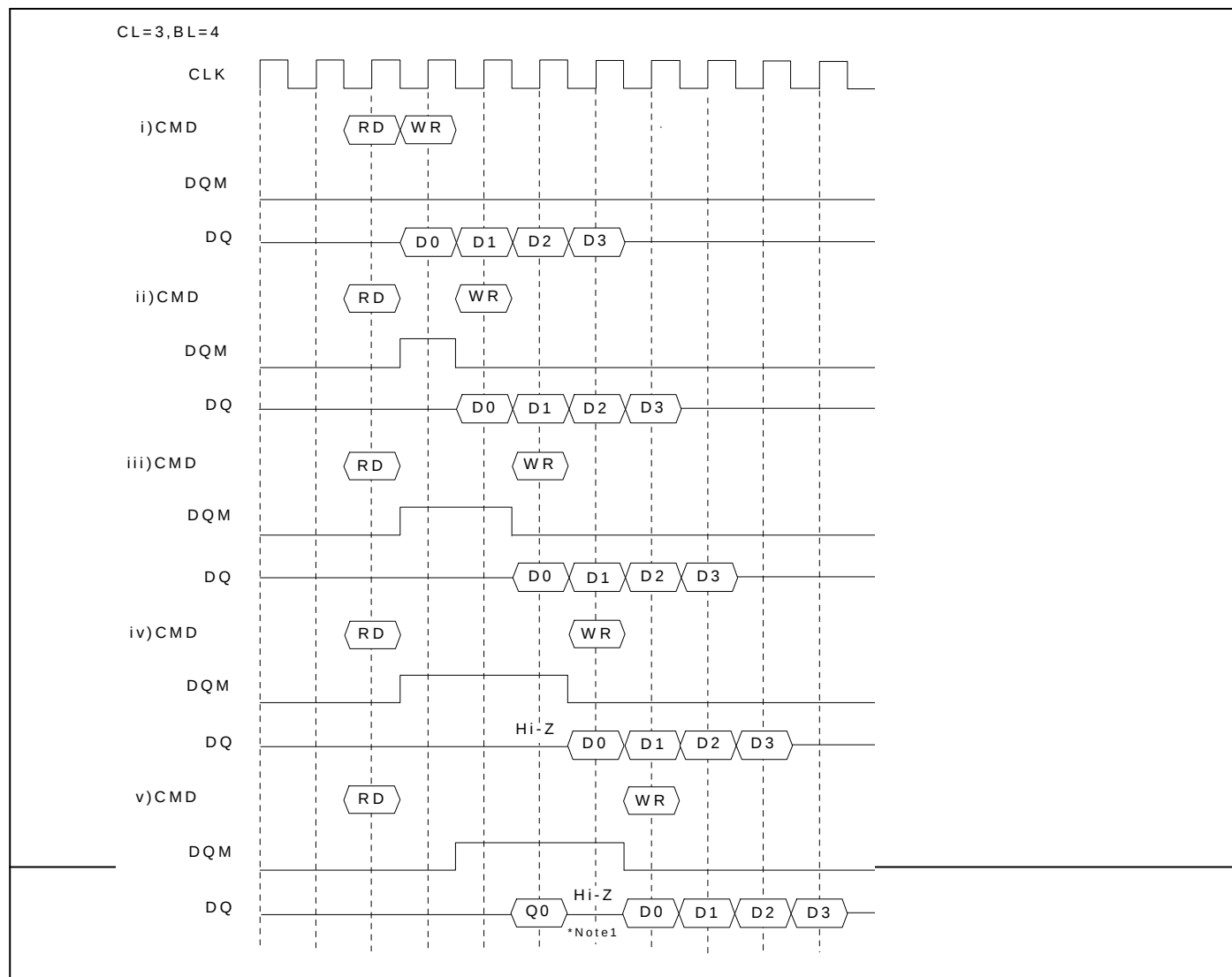
- \*Note: 1. CKE to CLK disable/enable = 1CLK.  
 2. DQM masks data out Hi-Z after 2CLKs which should be masked by CKE "L".  
 3. DQM masks both data-in and data-out.

### 3. $\overline{\text{CAS}}$ Interrupt (I)



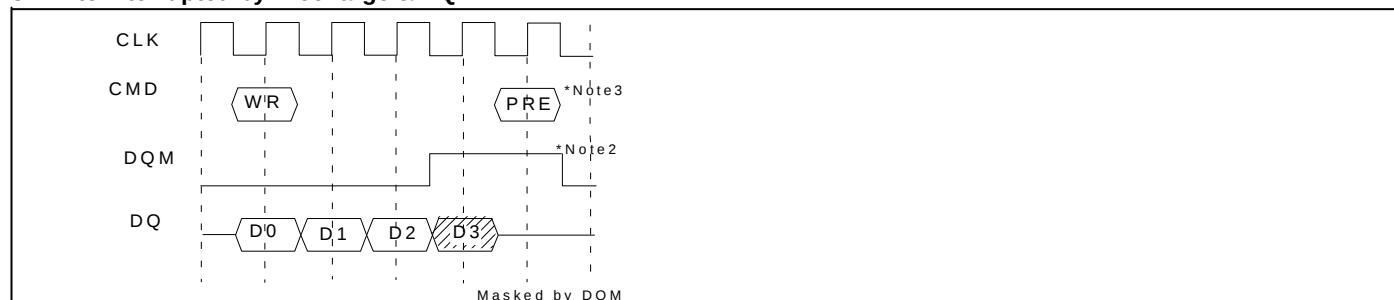
- \*Note:
1. By "interrupt" is meant to stop burst read/write by external before the end of burst.  
By "  $\overline{\text{CAS}}$  interrupt ", to stop burst read/write by  $\overline{\text{CAS}}$  access; read and write.
  2.  $t_{\text{CCD}}$ :  $\overline{\text{CAS}}$  to  $\overline{\text{CAS}}$  delay. (=1CLK)
  3.  $t_{\text{CDL}}$ : Last data in to new column address delay. (=1CLK)

## 4. CAS Interrupt (II): Read Interrupted by Write & DQM



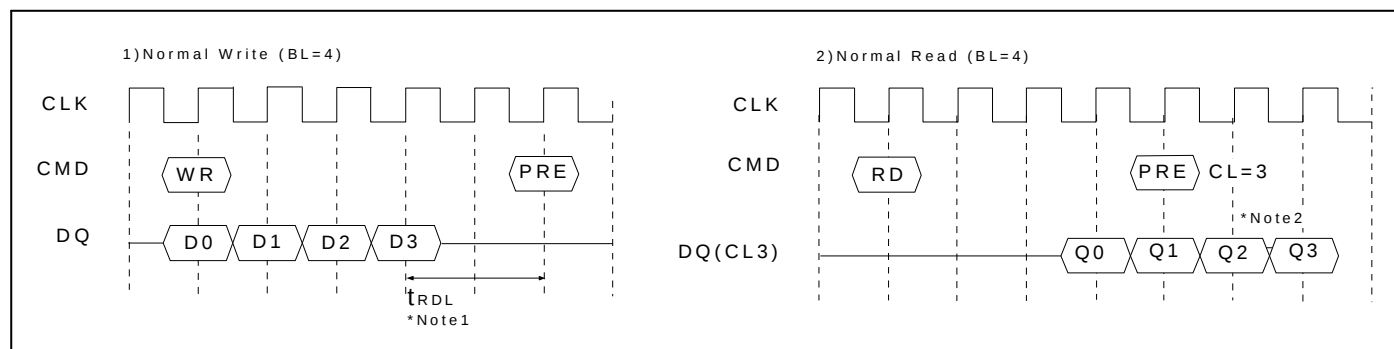
\*Note: 1. To prevent bus contention, there should be at least one gap between data in and data out.

## 5. Write Interrupted by Precharge & DQM

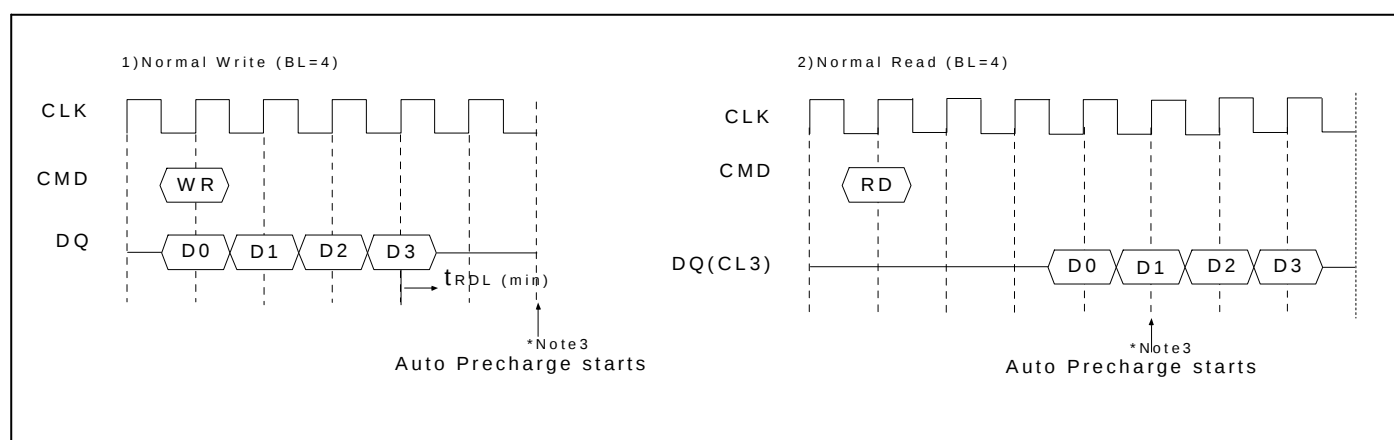


- \*Note:
1. To prevent bus contention, DQM should be issued which makes at least one gap between data in and data out.
  2. To inhibit invalid write, DQM should be issued.
  3. This precharge command and burst write command should be of the same bank, otherwise it is not precharge interrupt but only another bank precharge of four banks operation.

## 6. Precharge

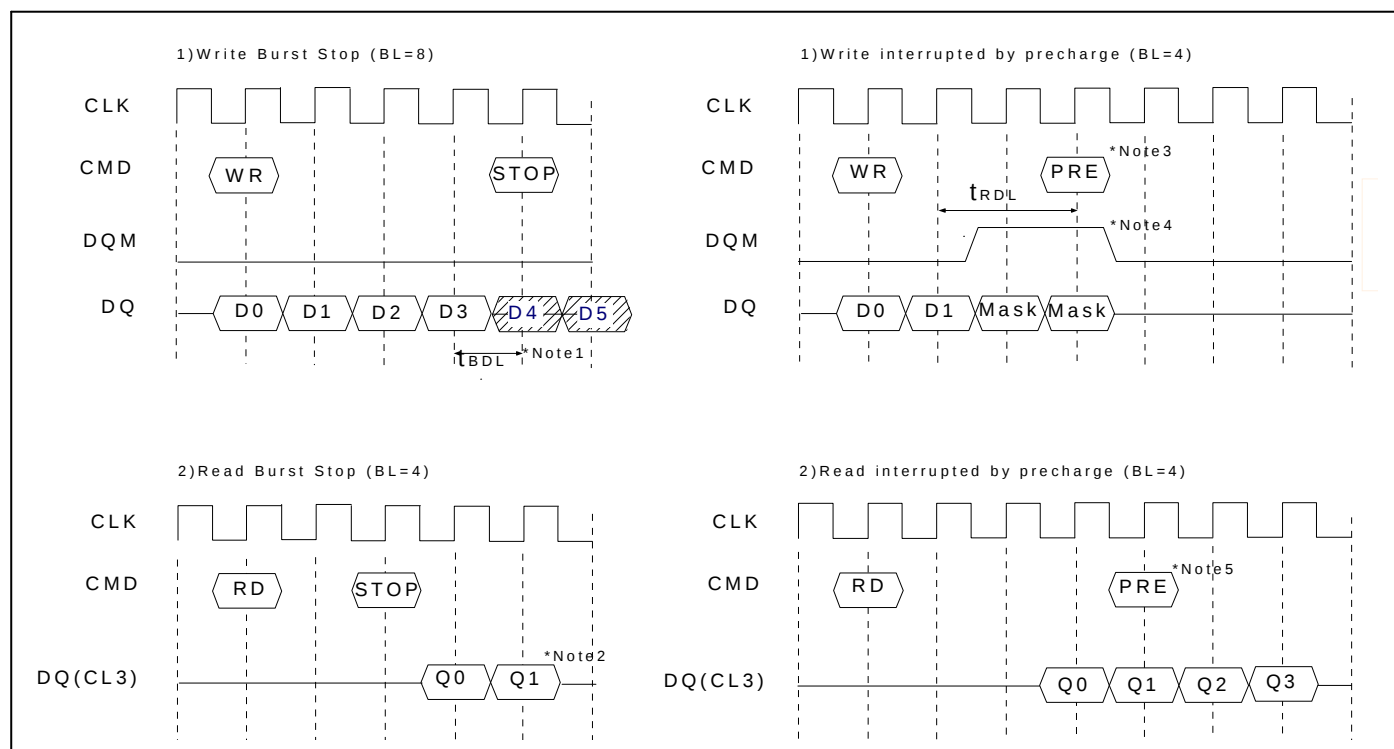


## 7. Auto Precharge

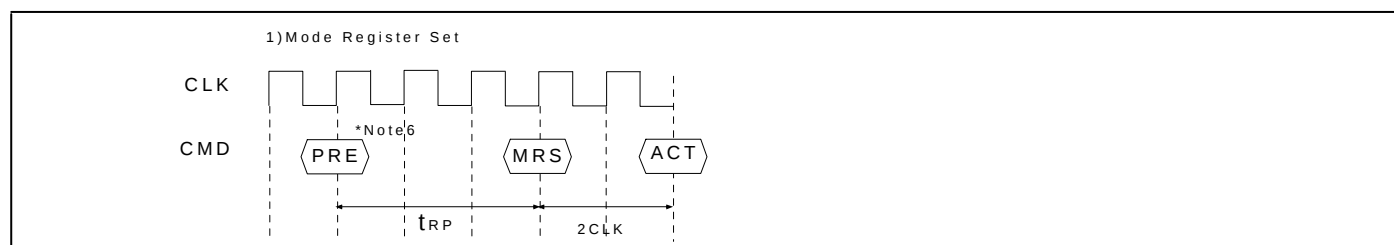


- \*Note:
1.  $t_{RDL}$ : Last data in to row precharge delay.
  2. Number of valid output data after row precharge: 2 for CAS Latency = 3 respectively.
  3. The row active command of the precharge bank can be issued after  $t_{RP}$  from this point.  
The new read/write command of other activated bank can be issued from this point.  
At burst read/write with auto precharge, CAS interrupt of the same/another bank is illegal.

## 8. Burst Stop & Interrupted by Precharge

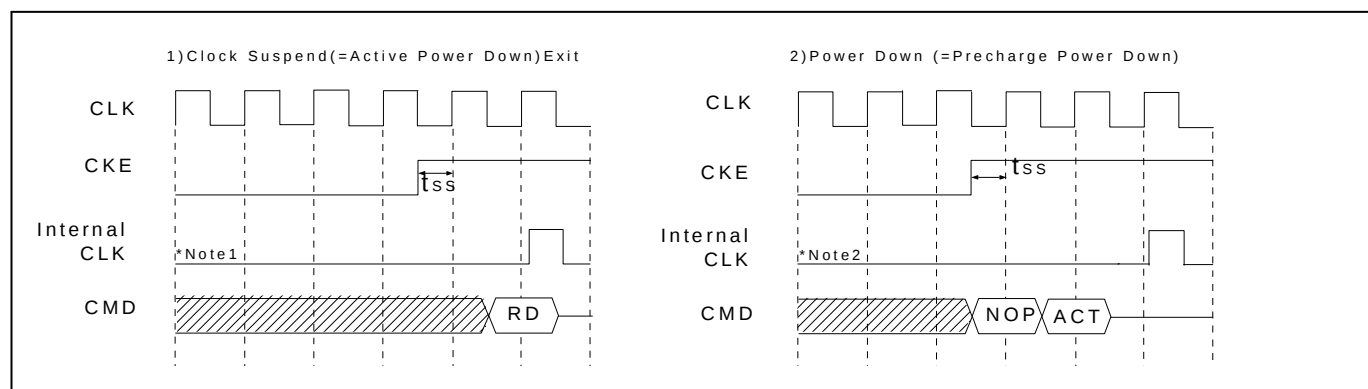


## 9. MRS

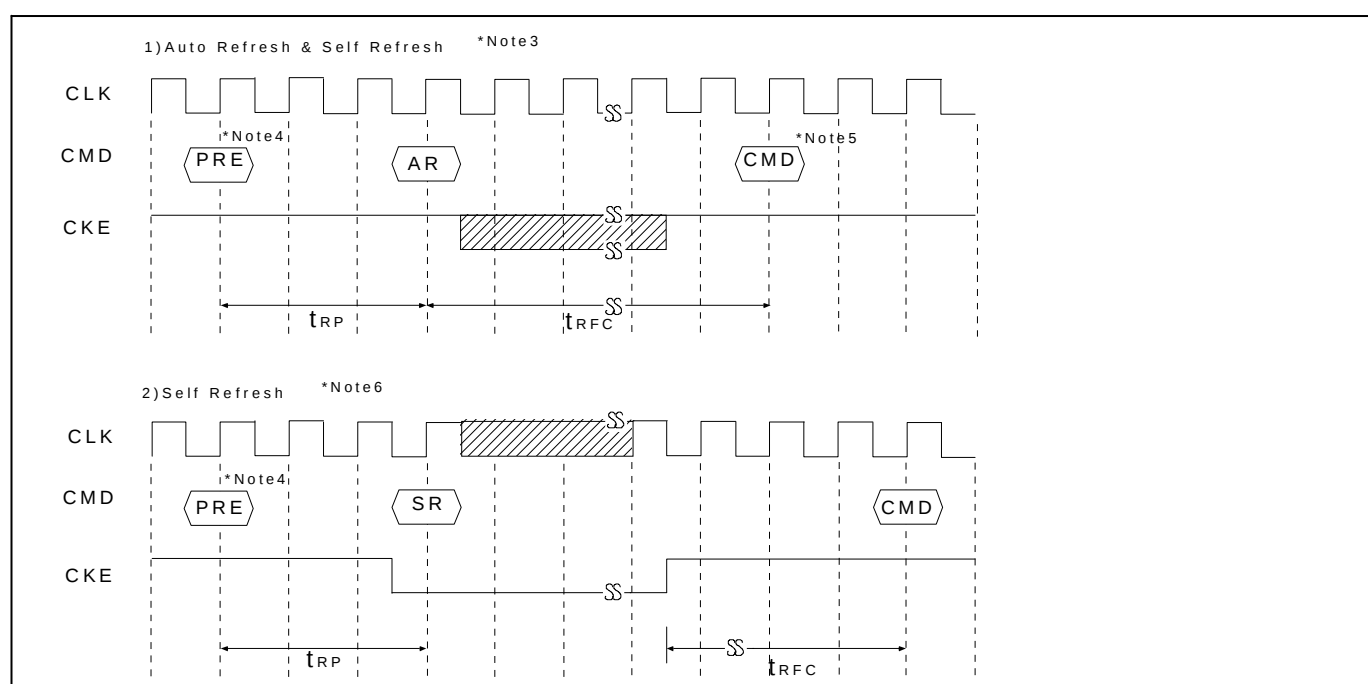


- \*Note:
1.  $t_{BDL}$ : 1 CLK; Last data in to burst stop delay.  
Read or write burst stop command is valid at every burst length.
  2. Number of valid output data after burst stop: 2 for CAS latency = 3 respectively.
  3. Write burst is terminated.  $t_{RDL}$  determines the last data write.
  4. DQM asserted to prevent corruption of locations D2 and D3.
  5. Precharge can be issued here or earlier (satisfying  $t_{RAS \text{ min}}$  delay) with DQM.
  6. PRE: All banks precharge, if necessary.  
MRS can be issued only at all banks precharge state.

## 10. Clock Suspend Exit & Power Down Exit



## 11. Auto Refresh & Self Refresh



- \*Note:
1. Active power down: one or more banks active state.
  2. Precharge power down: all banks precharge state.
  3. The auto refresh is the same as CBR refresh of conventional DRAM.  
No precharge commands are required after auto refresh command.  
During  $t_{RFC}$  from auto refresh command, any other command can not be accepted.
  4. Before executing auto/self refresh command, all banks must be idle state.
  5. MRS, Bank Active, Auto/Self Refresh, Power Down Mode Entry.
  6. During self refresh entry, refresh interval and refresh operation are performed internally.  
After self refresh entry, self refresh mode is kept while CKE is low.  
During self refresh entry, all inputs expect CKE will be don't cared, and outputs will be in Hi-Z state.  
For the time interval of  $t_{RFC}$  from self refresh exit command, any other command can not be accepted.  
4K cycles of burst auto refresh is required immediately before self refresh entry and immediately after self refresh exit.

## 12. About Burst Type Control

|                |                                                   |                                                                                                                                                                           |
|----------------|---------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Basic<br>MODE  | Sequential Counting                               | At MRS A3 = "0". See the BURST SEQUENCE TABLE. (BL = 4,8)<br>BL = 1, 2, 4, 8 and full page.                                                                               |
|                | Interleave Counting                               | At MRS A3 = "1". See the BURST SEQUENCE TABLE. (BL = 4,8)<br>BL = 4, 8 At BL =1, 2 Interleave Counting = Sequential Counting                                              |
| Random<br>MODE | Random Column Access<br>$t_{CCD} = 1 \text{ CLK}$ | Every cycle Read/Write Command with random column address can realize Random Column Access.<br>That is similar to Extended Data Out (EDO) Operation of conventional DRAM. |

## 13. About Burst Length Control

|                   |                                                          |                                                                                                                                                                                                                                                                                                                |
|-------------------|----------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Basic<br>MODE     | 1                                                        | At MRS A210 = "000"<br>At auto precharge. $t_{RAS}$ should not be violated.                                                                                                                                                                                                                                    |
|                   | 2                                                        | At MRS A210 = "001"<br>At auto precharge. $t_{RAS}$ should not be violated.                                                                                                                                                                                                                                    |
|                   | 4                                                        | At MRS A210 = "010"                                                                                                                                                                                                                                                                                            |
|                   | 8                                                        | At MRS A210 = "011"                                                                                                                                                                                                                                                                                            |
|                   | Full Page                                                | At MRS A210 = "111"<br>At the end of the burst length, burst is wrap-around.                                                                                                                                                                                                                                   |
| Random<br>MODE    | Burst Stop                                               | $t_{BDL} = 1$ , Valid DQ after burst stop is 2 for CAS latency 3 respectively.<br>Using burst stop command, any burst length control is possible.                                                                                                                                                              |
| Interrupt<br>MODE | $\overline{RAS}$ Interrupt<br>(Interrupted by Precharge) | Before the end of burst. Row precharge command of the same bank stops read /write burst with auto precharge.<br>$t_{RDL} = 2\text{clk}$ with DQM, Valid DQ after burst stop is 2 for CAS latency 3 respectively.<br>During read/write burst with auto precharge, $\overline{RAS}$ interrupt can not be issued. |
|                   | $\overline{CAS}$ Interrupt                               | Before the end of burst, new read/write stops read/write burst and starts new read/write burst.<br>During read/write burst with auto precharge, $\overline{CAS}$ interrupt can not be issued.                                                                                                                  |

**FUNCTION TRUTH TABLE (TABLE 1)**

| Current State             | $\overline{CS}$ | $\overline{RAS}$ | $\overline{CAS}$ | $\overline{WE}$ | BA      | ADDR       | ACTION                                   | Note |
|---------------------------|-----------------|------------------|------------------|-----------------|---------|------------|------------------------------------------|------|
| IDLE                      | H               | X                | X                | X               | X       | X          | NOP                                      |      |
|                           | L               | H                | H                | H               | X       | X          | NOP                                      |      |
|                           | L               | H                | H                | L               | X       | X          | ILLEGAL                                  | 2    |
|                           | L               | H                | L                | X               | BA      | CA, A10/AP | ILLEGAL                                  | 2    |
|                           | L               | L                | H                | H               | BA      | RA         | Row (&Bank) Active ; Latch RA            |      |
|                           | L               | L                | H                | L               | BA      | A10/AP     | NOP                                      | 4    |
|                           | L               | L                | L                | H               | X       | X          | Auto Refresh or Self Refresh             | 5    |
| Row Active                | L               | L                | L                | L               | OP code | OP code    | Mode Register Access                     | 5    |
|                           | H               | X                | X                | X               | X       | X          | NOP                                      |      |
|                           | L               | H                | H                | H               | X       | X          | NOP                                      |      |
|                           | L               | H                | H                | L               | X       | X          | ILLEGAL                                  | 2    |
|                           | L               | H                | L                | H               | BA      | CA, A10/AP | Begin Read ; latch CA ; determine AP     |      |
|                           | L               | H                | L                | L               | BA      | CA, A10/AP | Begin Write ; latch CA ; determine AP    |      |
|                           | L               | L                | H                | H               | BA      | RA         | ILLEGAL                                  | 2    |
| Read                      | L               | L                | H                | L               | BA      | A10/AP     | Precharge                                |      |
|                           | L               | L                | L                | X               | X       | X          | ILLEGAL                                  |      |
|                           | H               | X                | X                | X               | X       | X          | NOP (Continue Burst to End → Row Active) |      |
|                           | L               | H                | H                | H               | X       | X          | NOP (Continue Burst to End → Row Active) |      |
|                           | L               | H                | H                | L               | X       | X          | Term burst → Row active                  |      |
|                           | L               | H                | L                | H               | BA      | CA, A10/AP | Term burst, New Read, Determine AP       |      |
|                           | L               | H                | L                | L               | BA      | CA, A10/AP | Term burst, New Write, Determine AP      | 3    |
| Write                     | L               | L                | H                | H               | BA      | RA         | ILLEGAL                                  | 2    |
|                           | L               | L                | H                | L               | BA      | A10/AP     | Term burst, Precharge timing for Reads   |      |
|                           | L               | L                | L                | X               | X       | X          | ILLEGAL                                  |      |
|                           | H               | X                | X                | X               | X       | X          | NOP (Continue Burst to End → Row Active) |      |
|                           | L               | H                | H                | H               | X       | X          | NOP (Continue Burst to End → Row Active) |      |
|                           | L               | H                | H                | L               | X       | X          | Term burst → Row active                  |      |
|                           | L               | H                | L                | H               | BA      | CA, A10/AP | Term burst, New Read, Determine AP       | 3    |
| Read with Auto Precharge  | L               | H                | L                | L               | BA      | CA, A10/AP | Term burst, New Write, Determine AP      | 3    |
|                           | L               | L                | H                | H               | BA      | RA         | ILLEGAL                                  | 2    |
|                           | L               | L                | H                | L               | BA      | A10/AP     | Term burst, Precharge timing for Writes  | 3    |
|                           | L               | L                | L                | X               | X       | X          | ILLEGAL                                  |      |
|                           | H               | X                | X                | X               | X       | X          | NOP (Continue Burst to End → Row Active) |      |
|                           | L               | H                | H                | H               | X       | X          | NOP (Continue Burst to End → Row Active) |      |
|                           | L               | H                | H                | L               | X       | X          | ILLEGAL                                  |      |
| Write with Auto Precharge | L               | H                | L                | X               | BA      | CA, A10/AP | ILLEGAL                                  |      |
|                           | L               | L                | H                | X               | BA      | RA, RA10   | ILLEGAL                                  | 2    |
|                           | L               | L                | L                | X               | X       | X          | ILLEGAL                                  |      |
|                           | H               | X                | X                | X               | X       | X          | NOP (Continue Burst to End → Row Active) |      |
|                           | L               | H                | H                | H               | X       | X          | NOP (Continue Burst to End → Row Active) |      |
|                           | L               | H                | H                | L               | X       | X          | ILLEGAL                                  |      |
|                           | L               | H                | L                | X               | BA      | CA, A10/AP | ILLEGAL                                  |      |
| Write with Auto Precharge | L               | L                | H                | X               | BA      | RA, RA10   | ILLEGAL                                  | 2    |
|                           | L               | L                | L                | X               | X       | X          | ILLEGAL                                  |      |
|                           | L               | L                | L                | X               | X       | X          | ILLEGAL                                  |      |

| Current State           | $\overline{\text{CS}}$ | $\overline{\text{RAS}}$ | $\overline{\text{CAS}}$ | $\overline{\text{WE}}$ | BA | ADDR   | ACTION                           | Note |
|-------------------------|------------------------|-------------------------|-------------------------|------------------------|----|--------|----------------------------------|------|
| Precharging             | H                      | X                       | X                       | X                      | X  | X      | NOP → Idle after $t_{RP}$        |      |
|                         | L                      | H                       | H                       | H                      | X  | X      | NOP → Idle after $t_{RP}$        |      |
|                         | L                      | H                       | H                       | L                      | X  | X      | ILLEGAL                          | 2    |
|                         | L                      | H                       | L                       | X                      | BA | CA     | ILLEGAL                          | 2    |
|                         | L                      | L                       | H                       | H                      | BA | RA     | ILLEGAL                          | 2    |
| Row Activating          | L                      | L                       | H                       | L                      | BA | A10/AP | NOP → Idle after $t_{RP}$        | 4    |
|                         | L                      | L                       | L                       | X                      | X  | X      | ILLEGAL                          |      |
|                         | H                      | X                       | X                       | X                      | X  | X      | NOP → Row Active after $t_{RCD}$ |      |
|                         | L                      | H                       | H                       | H                      | X  | X      | NOP → Row Active after $t_{RCD}$ |      |
|                         | L                      | H                       | H                       | L                      | X  | X      | ILLEGAL                          | 2    |
|                         | L                      | H                       | L                       | X                      | BA | CA     | ILLEGAL                          | 2    |
|                         | L                      | L                       | H                       | H                      | BA | RA     | ILLEGAL                          | 2    |
|                         | L                      | L                       | H                       | L                      | BA | A10/AP | ILLEGAL                          | 2    |
| Refreshing              | L                      | L                       | L                       | X                      | X  | X      | ILLEGAL                          |      |
|                         | H                      | X                       | X                       | X                      | X  | X      | NOP → Idle after $t_{RFC}$       |      |
|                         | L                      | H                       | H                       | X                      | X  | X      | NOP → Idle after $t_{RFC}$       |      |
|                         | L                      | H                       | L                       | X                      | X  | X      | ILLEGAL                          |      |
|                         | L                      | L                       | H                       | X                      | X  | X      | ILLEGAL                          |      |
| Mode Register Accessing | L                      | L                       | L                       | X                      | X  | X      | ILLEGAL                          |      |
|                         | H                      | X                       | X                       | X                      | X  | X      | NOP → Idle after 2clocks         |      |
|                         | L                      | H                       | H                       | H                      | X  | X      | NOP → Idle after 2clocks         |      |
|                         | L                      | H                       | H                       | L                      | X  | X      | ILLEGAL                          |      |
|                         | L                      | H                       | L                       | X                      | X  | X      | ILLEGAL                          |      |
| Mode Register Accessing | L                      | L                       | X                       | X                      | X  | X      | ILLEGAL                          |      |

Abbreviations:

RA = Row Address

NOP = No Operation Command

BA = Bank Address

CA = Column Address

AP = Auto Precharge

- \*Note:
1. All entries assume the CKE was active (High) during the precharge clock and the current clock cycle.
  2. Illegal to bank in specified state; Function may be legal in the bank indicated by BA, depending on the state of the bank.
  3. Must satisfy bus contention, bus turn around, and/or write recovery requirements.
  4. NOP to bank precharge or in idle state. May precharge bank indicated by BA (and A10/AP).
  5. Illegal if any bank is not idle.

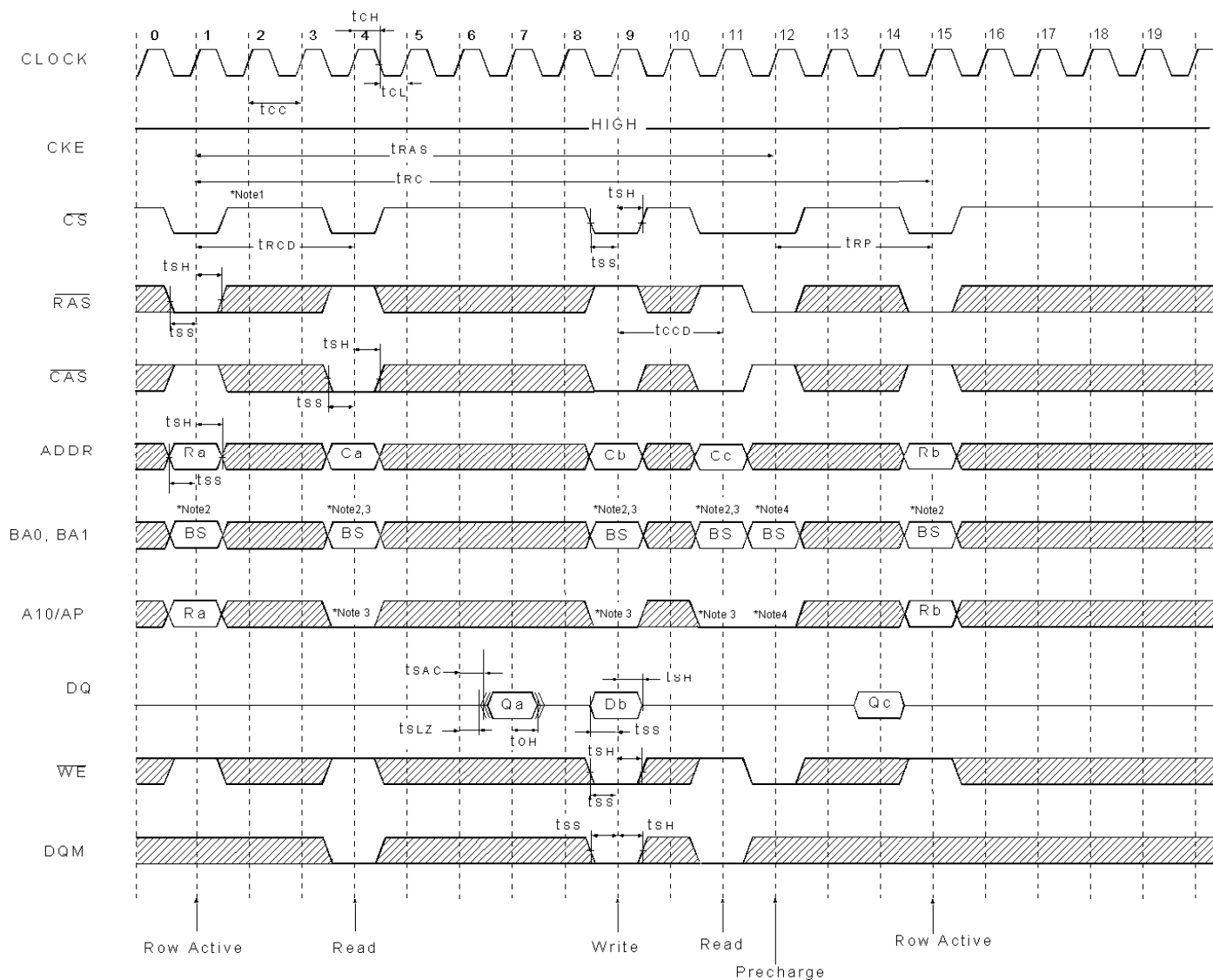
**FUNCTION TRUTH TABLE (TABLE2)**

| Current State                     | CKE (n-1) | CKE n | $\overline{CS}$ | $\overline{RAS}$ | $\overline{CAS}$ | $\overline{WE}$ | ADDR    | ACTION                                         | Note |
|-----------------------------------|-----------|-------|-----------------|------------------|------------------|-----------------|---------|------------------------------------------------|------|
| Self Refresh                      | H         | X     | X               | X                | X                | X               | X       | INVALID                                        |      |
|                                   | L         | H     | H               | X                | X                | X               | X       | Exit Self Refresh → Idle after $t_{RFC}$ (ABI) | 6    |
|                                   | L         | H     | L               | H                | H                | H               | X       | Exit Self Refresh → Idle after $t_{RFC}$ (ABI) | 6    |
|                                   | L         | H     | L               | H                | H                | L               | X       | ILLEGAL                                        |      |
|                                   | L         | H     | L               | H                | L                | X               | X       | ILLEGAL                                        |      |
|                                   | L         | H     | L               | L                | X                | X               | X       | ILLEGAL                                        |      |
|                                   | L         | L     | X               | X                | X                | X               | X       | NOP (Maintain Self Refresh)                    |      |
| All Banks Precharge Power Down    | H         | X     | X               | X                | X                | X               | X       | INVALID                                        |      |
|                                   | L         | H     | H               | X                | X                | X               | X       | Exit Self Refresh → ABI                        | 7    |
|                                   | L         | H     | L               | H                | H                | H               | X       | Exit Self Refresh → ABI                        | 7    |
|                                   | L         | H     | L               | H                | H                | L               | X       | ILLEGAL                                        |      |
|                                   | L         | H     | L               | H                | L                | X               | X       | ILLEGAL                                        |      |
|                                   | L         | H     | L               | L                | X                | X               | X       | ILLEGAL                                        |      |
|                                   | L         | L     | X               | X                | X                | X               | X       | NOP (Maintain Low Power Mode)                  |      |
| All Banks Idle                    | H         | H     | X               | X                | X                | X               | X       | Refer to Table1                                |      |
|                                   | H         | L     | H               | X                | X                | X               | X       | Enter Power Down                               | 8    |
|                                   | H         | L     | L               | H                | H                | H               | X       | Enter Power Down                               | 8    |
|                                   | H         | L     | L               | H                | H                | L               | X       | ILLEGAL                                        |      |
|                                   | H         | L     | L               | L                | H                | H               | X       | ILLEGAL                                        |      |
|                                   | H         | L     | L               | L                | L                | H               | RA      | Row (& Bank) Active                            |      |
|                                   | H         | L     | L               | L                | L                | L               | X       | Enter Self Refresh                             | 8    |
|                                   | H         | L     | L               | L                | L                | L               | OP Code | Mode Register Access                           |      |
| Any State other than Listed above | L         | L     | X               | X                | X                | X               | X       | NOP                                            |      |
|                                   | H         | H     | X               | X                | X                | X               | X       | Refer to Operations in Table 1                 |      |
|                                   | H         | L     | X               | X                | X                | X               | X       | Begin Clock Suspend next cycle                 | 9    |
|                                   | L         | H     | X               | X                | X                | X               | X       | Exit Clock Suspend next cycle                  | 9    |
|                                   | L         | L     | X               | X                | X                | X               | X       | Maintain Clock Suspend                         |      |

Abbreviations: ABI = All Banks Idle, RA = Row Address

- \*Note:
- 6.CKE low to high transition is asynchronous.
  - 7.CKE low to high transition is asynchronous if restart internal clock.  
A minimum setup time  $1CLK + t_{ss}$  must be satisfy before any command other than exit.
  - 8.Power down and self refresh can be entered only from the all banks idle state.
  - 9.Must be a legal command.

## Single Bit Read-Write-Read Cycle (Same Page) @ CAS Latency = 3, Burst Length = 1



Don't Care

- Note:
1. All input expect CKE & DQM can be don't care when  $\overline{CS}$  is high at the CLK high going edge.
  2. Bank active @ read/write are controlled by BA0~BA1.

| BA1 | BA0 | Active & Read/Write |
|-----|-----|---------------------|
| 0   | 0   | Bank A              |
| 0   | 1   | Bank B              |
| 1   | 0   | Bank C              |
| 1   | 1   | Bank D              |

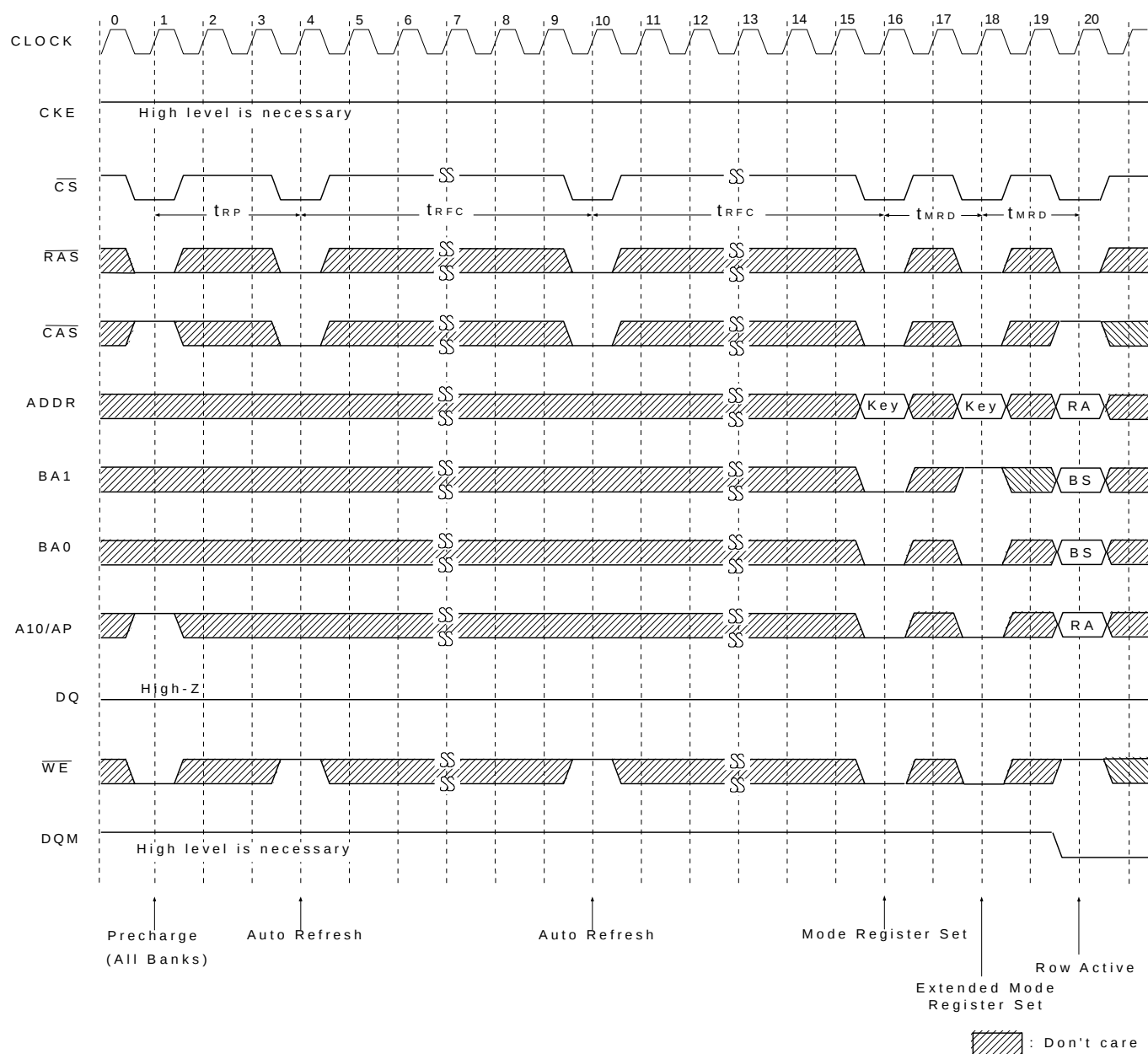
3. Enable and disable auto precharge function are controlled by A10/AP in read/write command

| A10/AP | BA1 | BA0 | Operating                                                    |
|--------|-----|-----|--------------------------------------------------------------|
| 0      | 0   | 0   | Disable auto precharge, leave A bank active at end of burst. |
|        | 0   | 1   | Disable auto precharge, leave B bank active at end of burst. |
|        | 1   | 0   | Disable auto precharge, leave C bank active at end of burst. |
|        | 1   | 1   | Disable auto precharge, leave D bank active at end of burst. |
| 1      | 0   | 0   | Enable auto precharge, precharge bank A at end of burst.     |
|        | 0   | 1   | Enable auto precharge, precharge bank B at end of burst.     |
|        | 1   | 0   | Enable auto precharge, precharge bank C at end of burst.     |
|        | 1   | 1   | Enable auto precharge, precharge bank D at end of burst.     |

4. A10/AP and BA0~BA1 control bank precharge when precharge is asserted.

| A10/AP | BA1 | BA0 | Precharge |
|--------|-----|-----|-----------|
| 0      | 0   | 0   | Bank A    |
| 0      | 0   | 1   | Bank B    |
| 0      | 1   | 0   | Bank C    |
| 0      | 1   | 1   | Bank D    |
| 1      | X   | X   | All Banks |

## Power Up Sequence

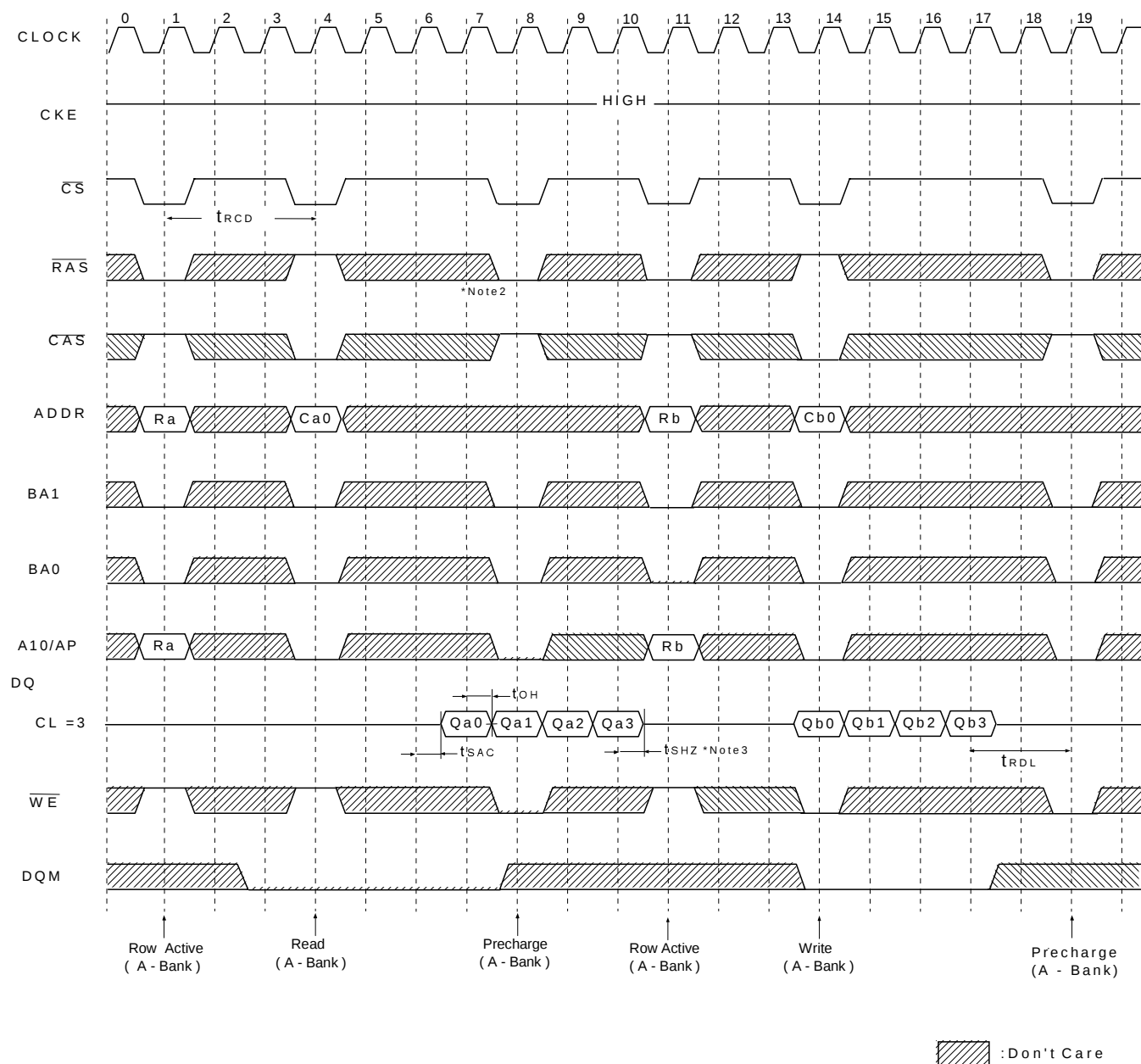


## Power-Up and Initialization Sequence

The following sequence is required for POWER UP and Initialization.

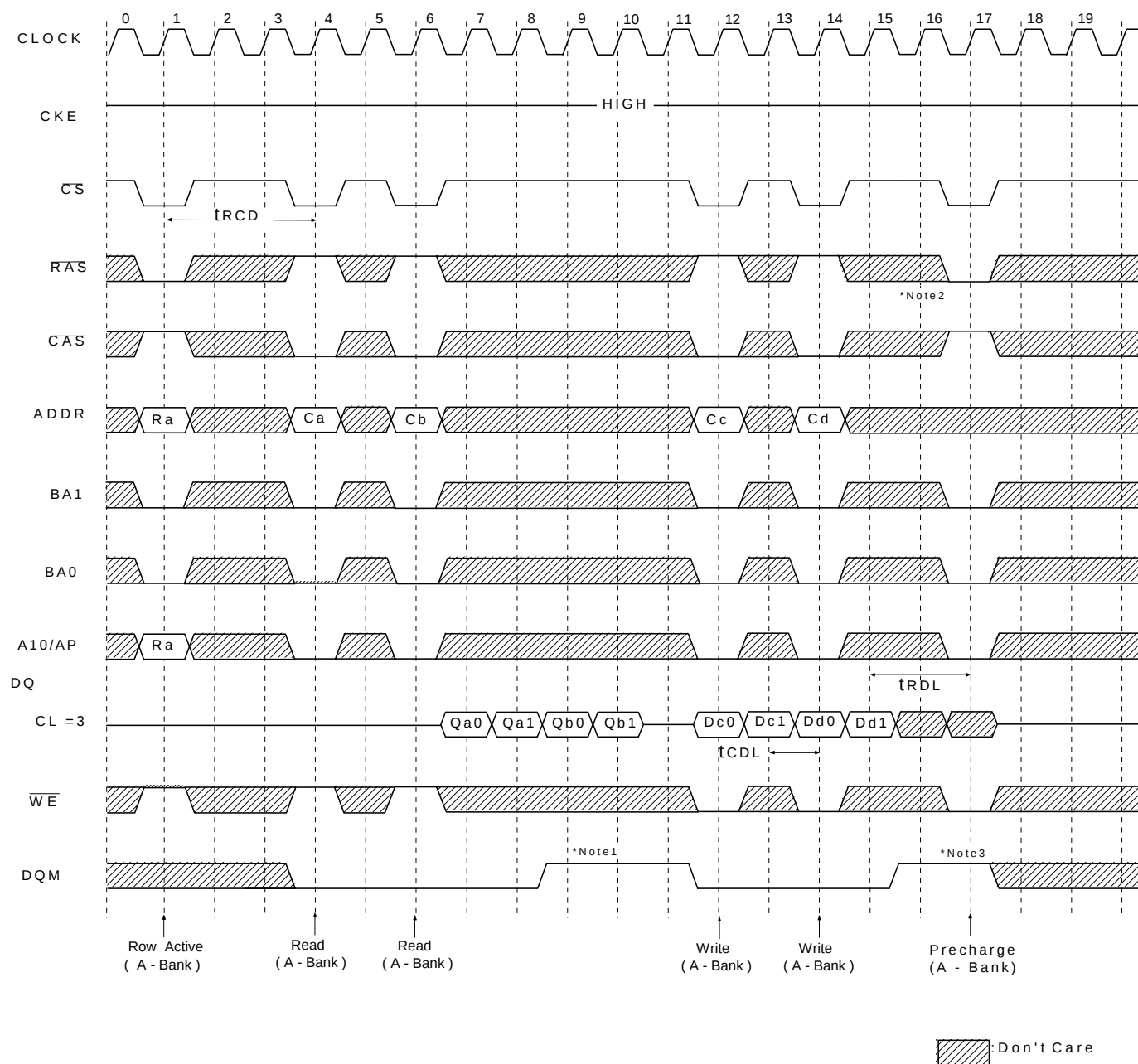
1. Apply power and attempt to maintain CKE at a low state (all other inputs may be undefined.)
  - Apply  $V_{DD}$  before or at the same time as  $V_{DDQ}$
  - Apply  $V_{DDQ}$
2. Start clock and maintain stable condition for a minimum.
3. The minimum of 200us after stable power and clock (CLK), apply NOP & take CKE high.
4. Issue precharge commands for all banks of the device.
5. Issue 2 or more auto-refresh commands.
6. Issue mode register set command to initialize the mode register.
7. Issue extended mode register set command to set PASR and DS.

## Read & Write Cycle at Same Bank @ Burst Length = 4



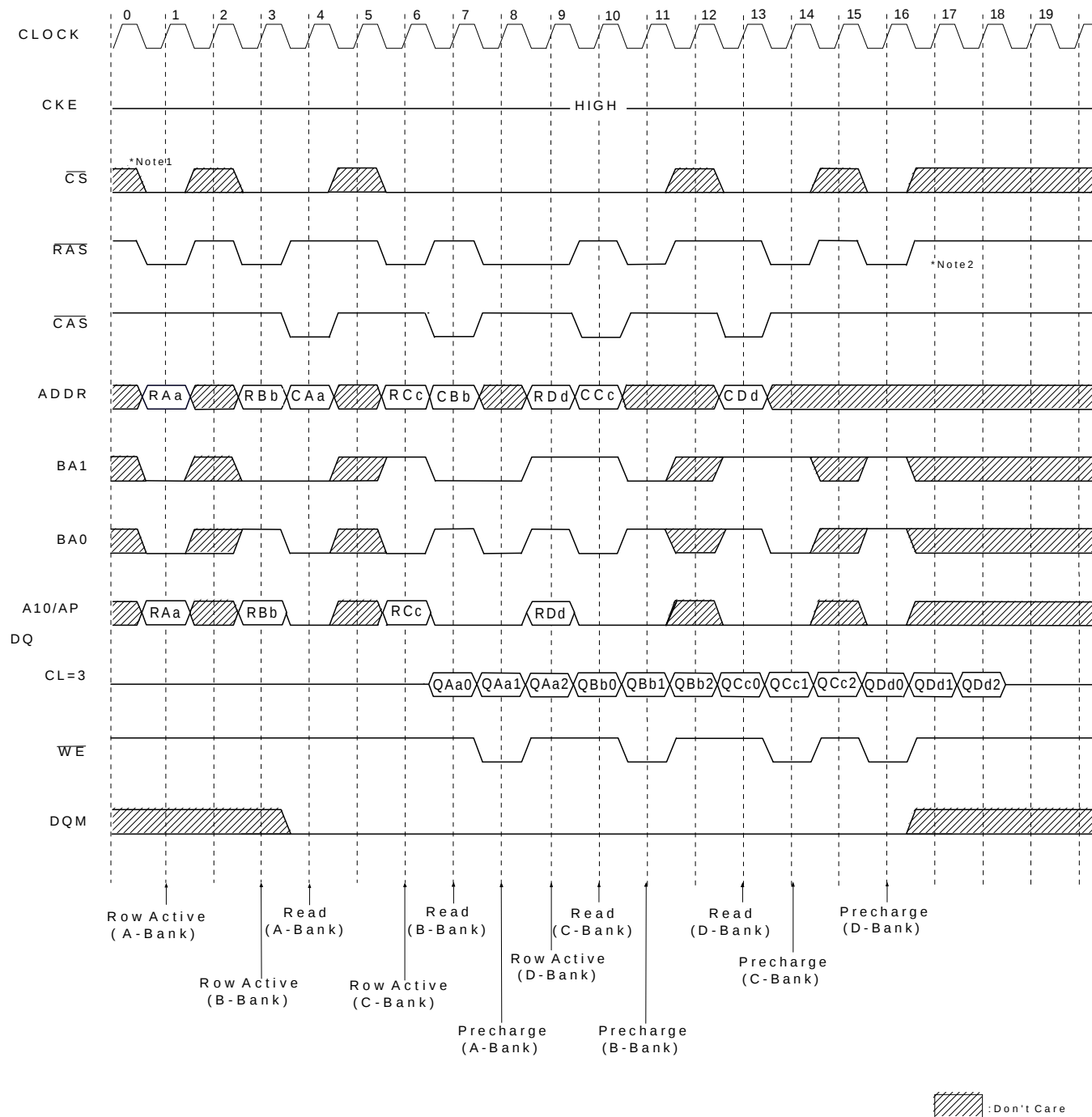
- \*Note:
1. Minimum row cycle times is required to complete internal DRAM operation.
  2. Row precharge can interrupt burst on any cycle. [CAS Latency-1] number of valid output data is available after Row precharge. Last valid output will be Hi-Z ( $t_{SHZ}$ ) after the clock.
  3. Output will be Hi-Z after the end of burst. (1, 2, 4, 8 & Full page bit burst)

## Page Read & Write Cycle at Same Bank @ Burst Length = 4



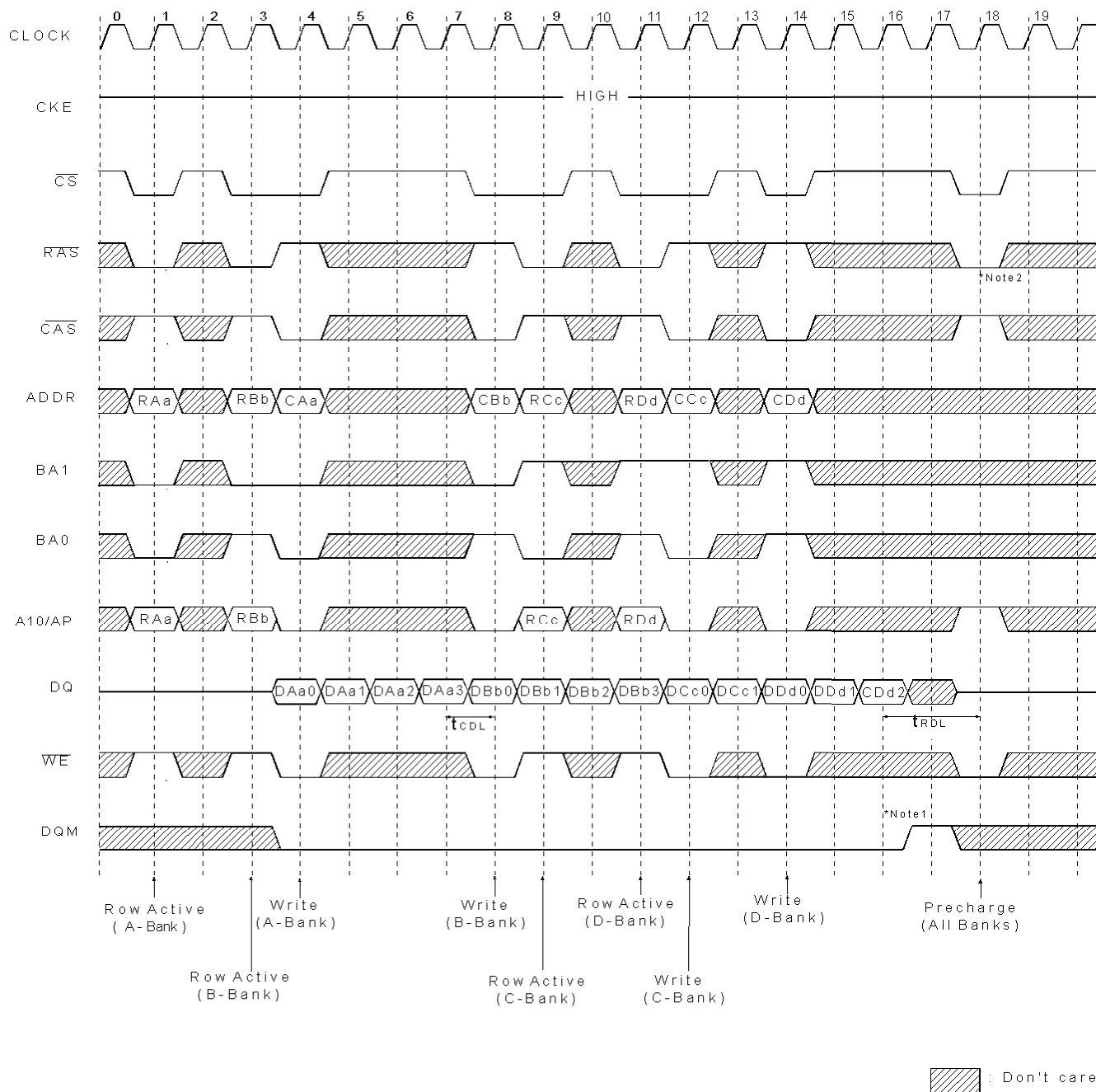
- Note: 1. To Write data before burst read ends. DQM should be asserted three cycles prior to write command to avoid bus contention.
2. Row precharge will interrupt writing. Last data input,  $t_{RDL}$  before row precharge, will be written.
3. DQM should mask invalid input data on precharge command cycle when asserting precharge before end of burst. Input data after Row precharge cycle will be masked internally.

## Page Read Cycle at Different Bank @ Burst Length = 4



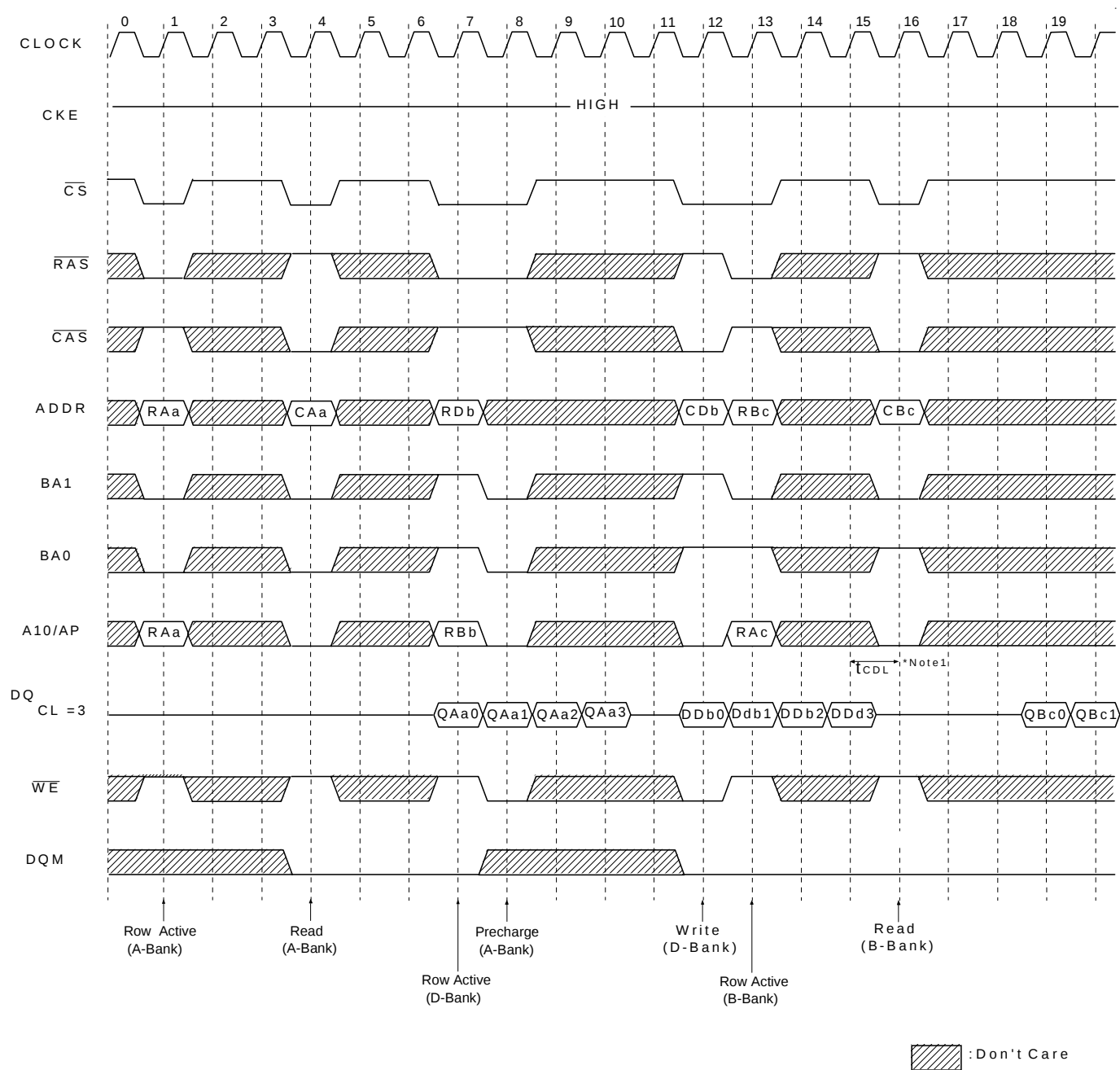
Note: 1.  $\overline{CS}$  can be don't cared when  $\overline{RAS}$ ,  $\overline{CAS}$  and  $\overline{WE}$  are high at the clock high going edge.  
 2. To interrupt a burst read by row precharge, both the read and the precharge banks must be the same.

## Page Write Cycle at Different Bank @ Burst Length = 4



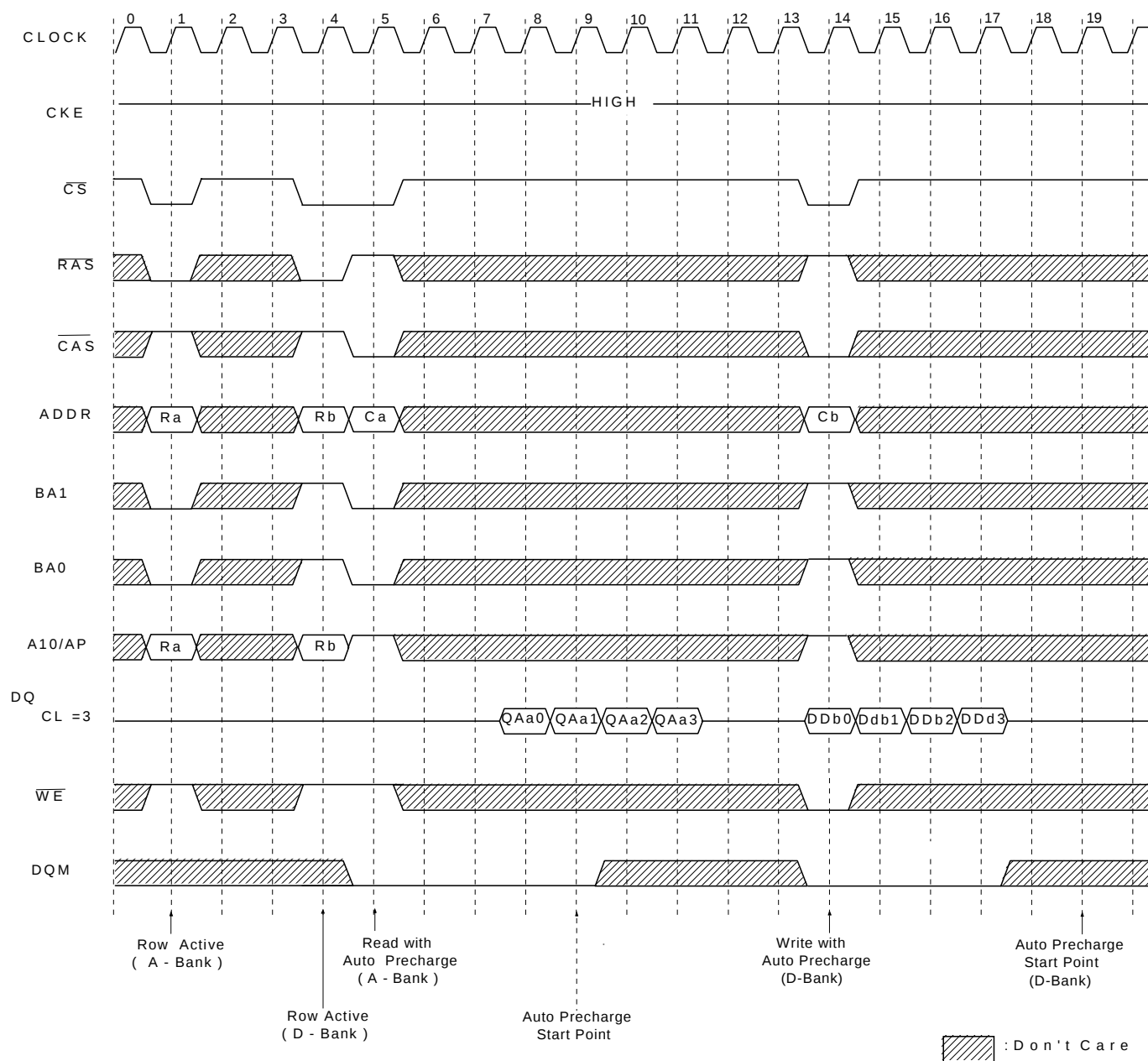
\*Note: 1. To interrupt burst write by Row precharge, DQM should be asserted to mask invalid input data.  
2. To interrupt burst write by Row precharge, both the write and the precharge banks must be the same.

## Read & Write Cycle at Different Bank @ Burst Length = 4



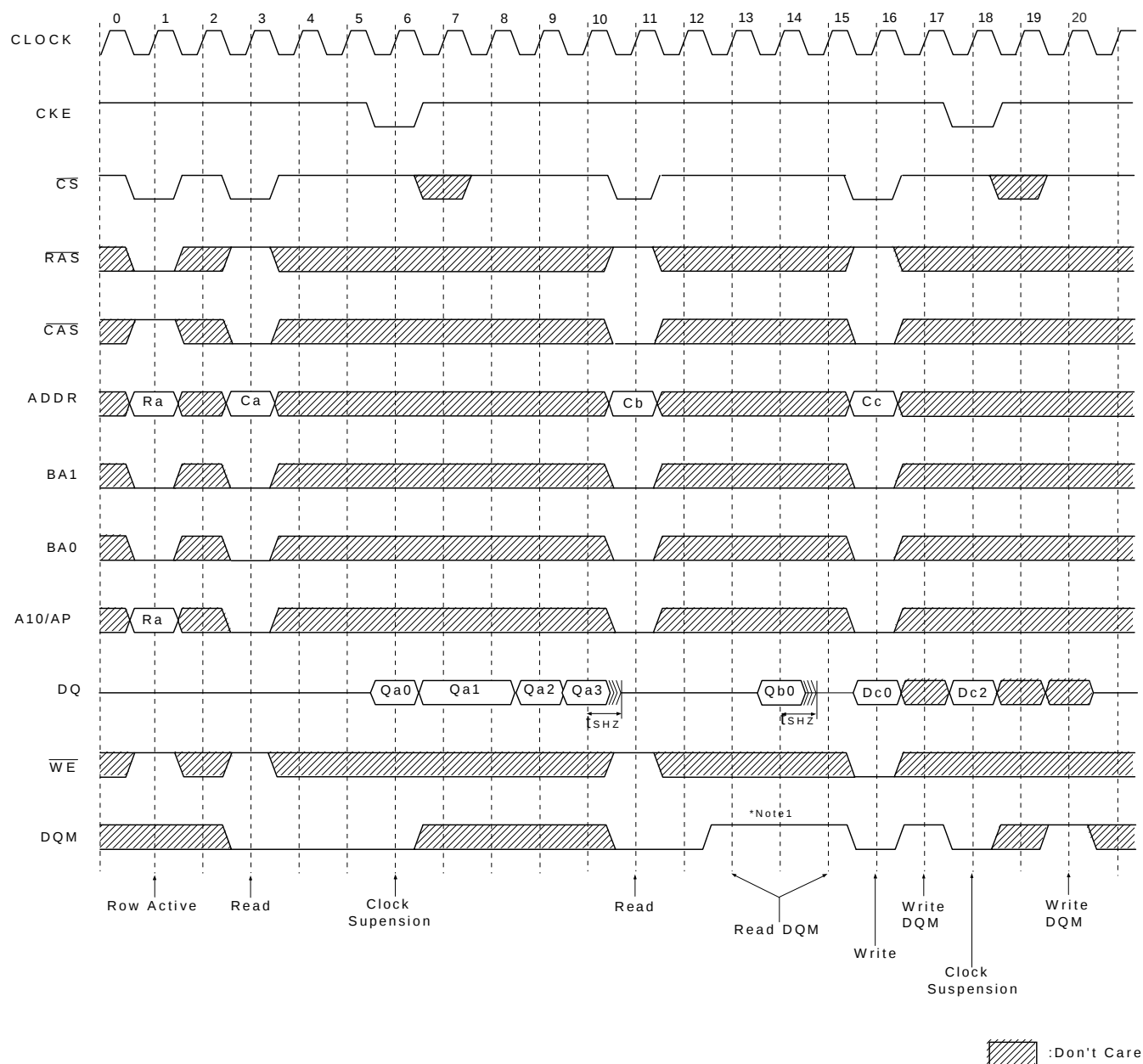
\*Note: 1.  $t_{CDL}$  should be met to complete write.

## Read & Write cycle with Auto Precharge @ Burst Length = 4



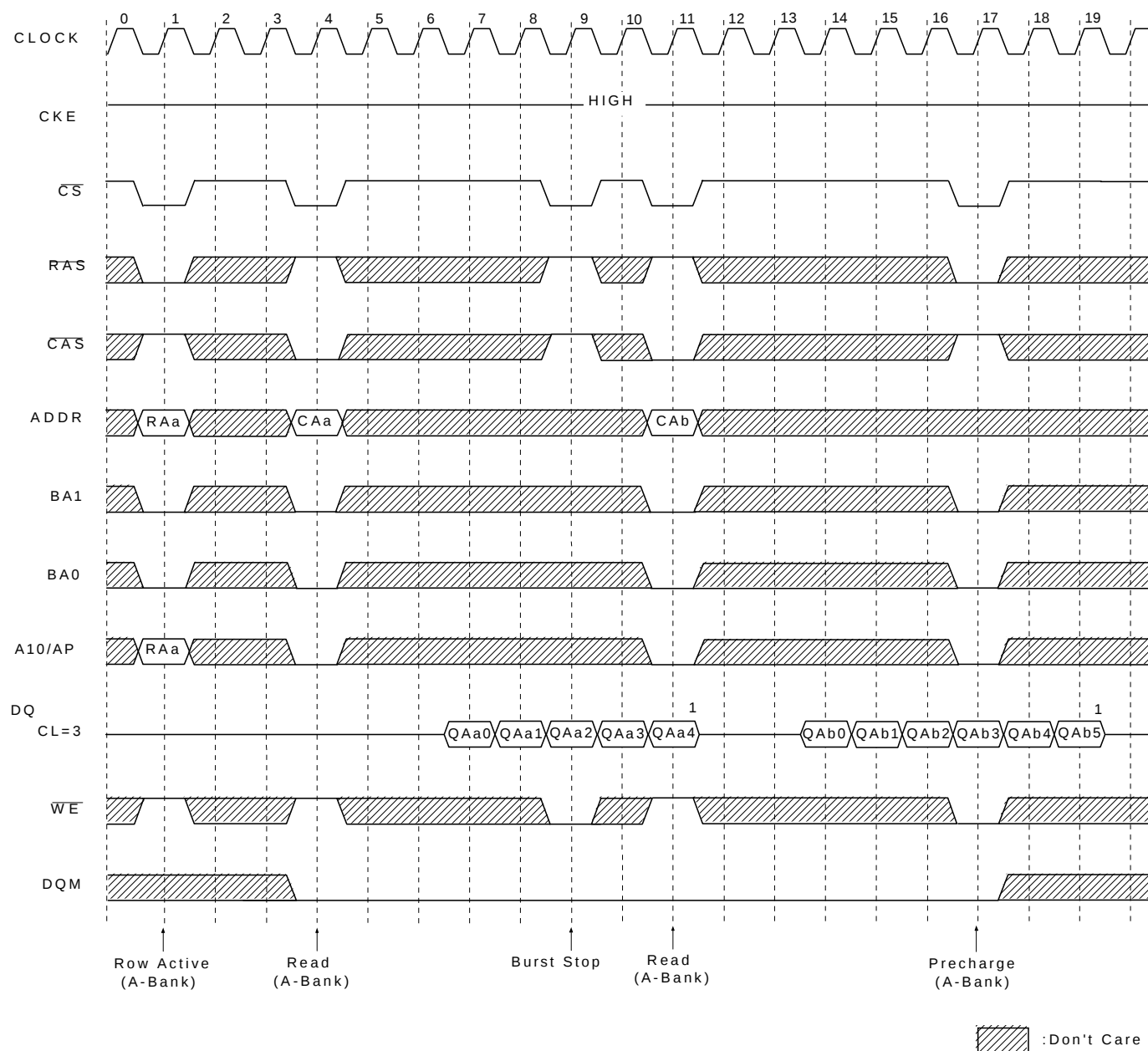
\*Note: 1.  $t_{CDL}$  should be controlled to meet minimum  $t_{RAS}$  before internal precharge start.  
(In the case of Burst Length = 1 & 2)

## Clock Suspension & DQM Operation Cycle @ CAS Latency = 3, Burst Length = 4



\*Note: 1. DQM is needed to prevent bus contention

## Read interrupted by Precharge Command & Read Burst Stop Cycle @ Burst Length = Full page



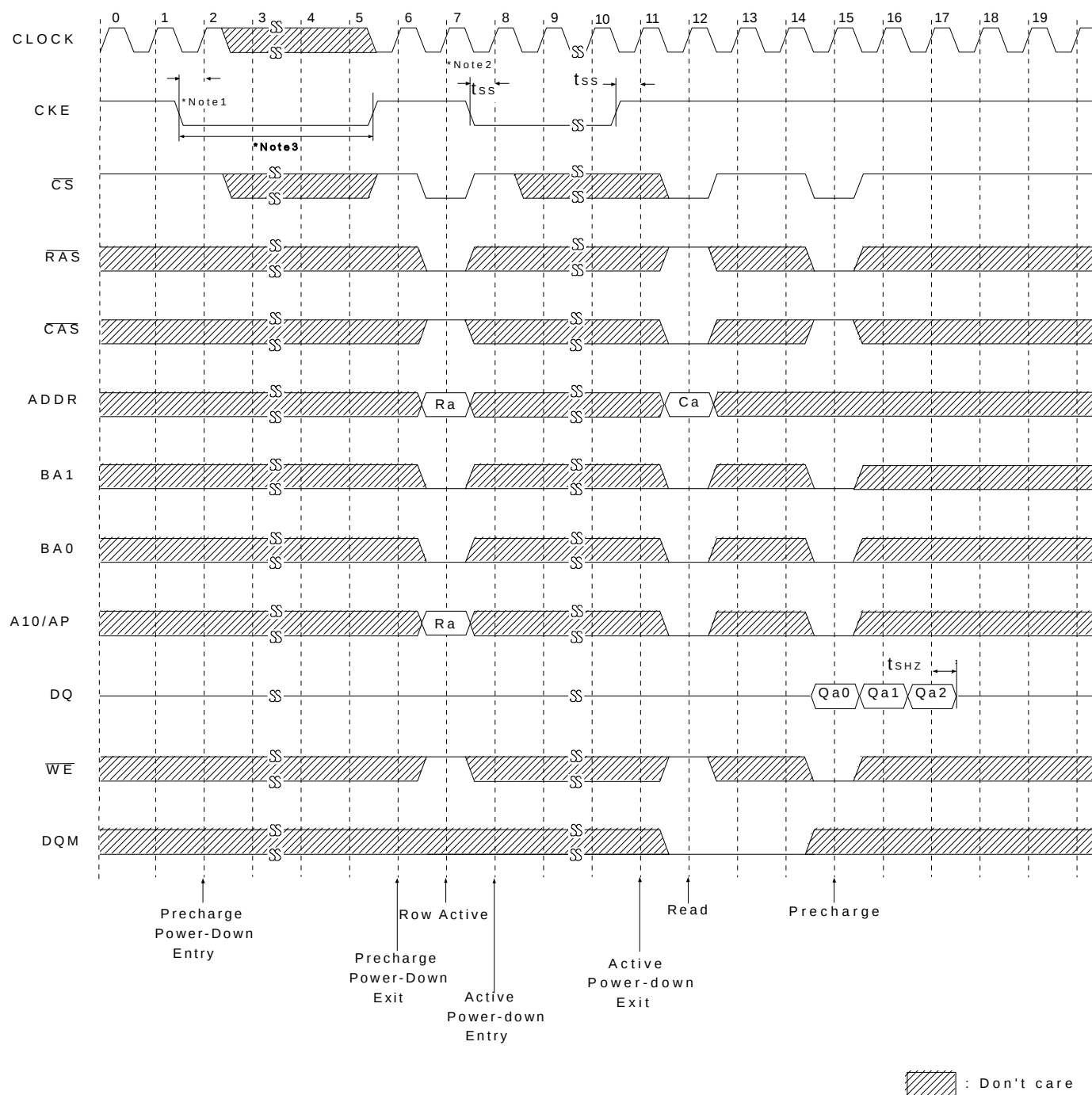
- \*Note:
1. About the valid DQs after burst stop, it is same as the case of  $\overline{\text{RAS}}$  interrupt. This case is illustrated above timing diagram. See the label 1.  
But at burst write, Burst stop and  $\overline{\text{RAS}}$  interrupt should be compared carefully. Refer the timing diagram of "Full page write burst stop cycles".
  2. Burst stop is valid at every burst length.

## Write interrupted by Precharge Command & Write Burst Stop Cycle @ Burst Length = Full page



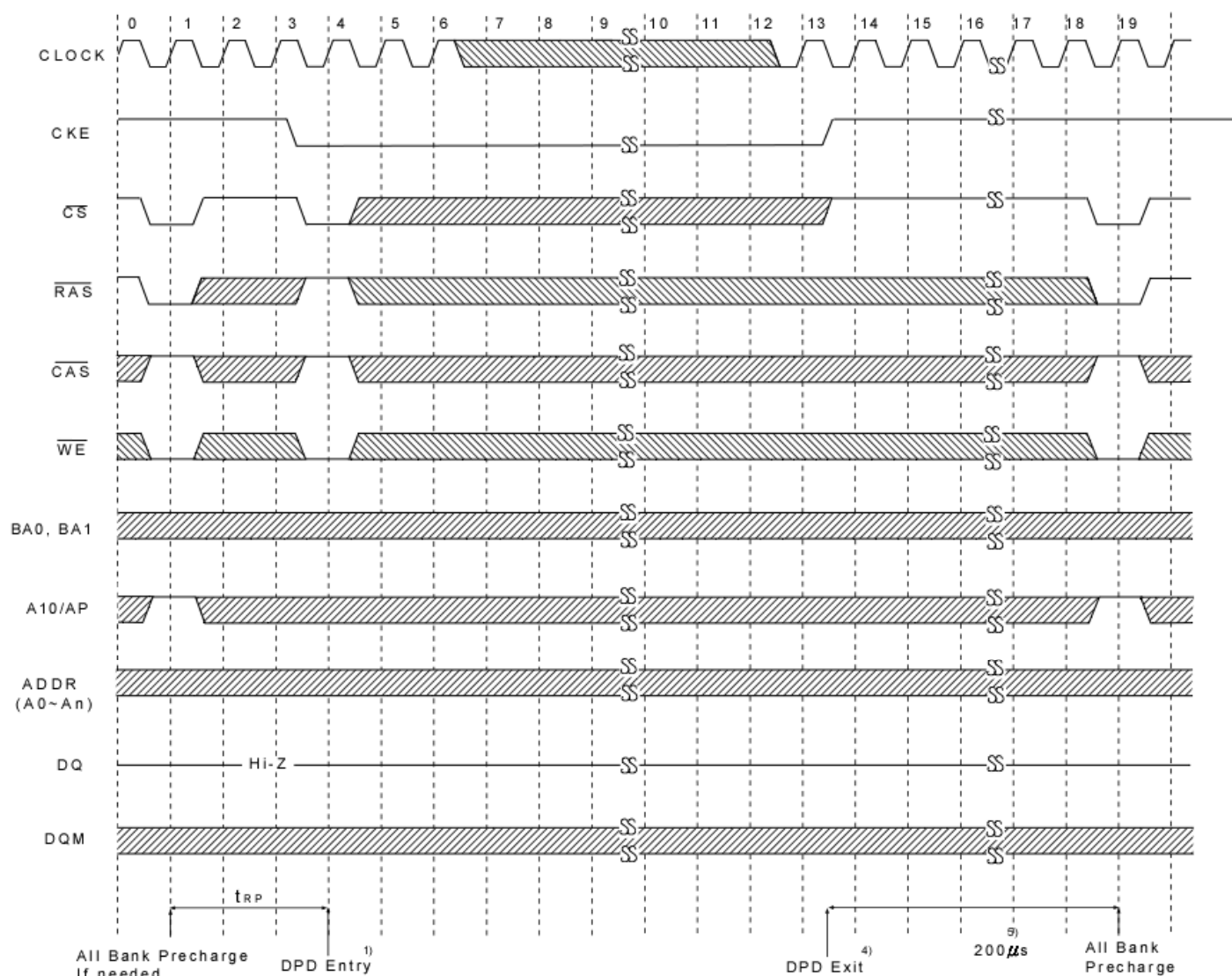
- \*Note:
1. Data-in at the cycle of interrupted by precharge can not be written into the corresponding memory cell. It is defined by AC parameter of  $t_{RDL}$ .  
DQM at write interrupted by precharge command is needed to prevent invalid write.  
DQM should mask invalid input data on precharge command cycle when asserting precharge before end of burst.  
Input data after Row precharge cycle will be masked internally.
  2. Burst stop is valid at every burst length.

## Active/Precharge Power Down Mode @ CAS Latency = 3, Burst Length = 4



- \*Note:
1. All banks should be in idle state prior to entering precharge power down mode.
  2. CKE should be set high at least 1CLK +  $t_{ss}$  prior to Row active command.
  3. Can not violate minimum refresh specification. (64ms)

## Deep Power Down Mode Entry & Exit Cycle



Note:

### DEFINITION OF DEEP POWER MODE FOR Mobile SDRAM:

Deep Power Down Mode is an operating mode to achieve maximum power reduction by cutting the power of the whole memory of the device. Once the device enters in Deep Power Down Mode, data will not be retained. Full initialization is required when the device exits from Deep Power Down Mode.

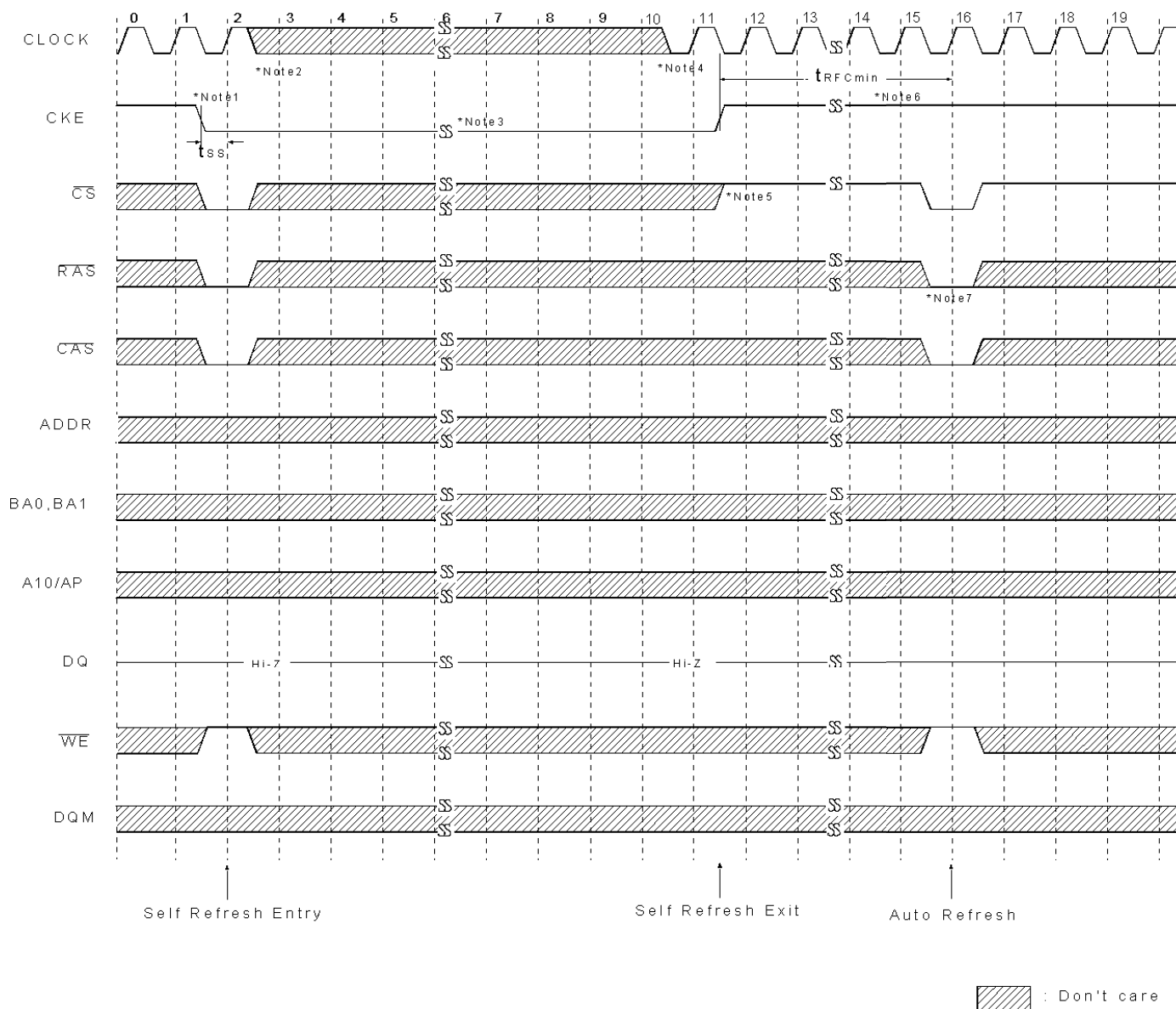
### TO ENTER DEEP POWER DOWN MODE

- 1) The deep power down mode is entered by having  $\overline{CS}$  and  $\overline{WE}$  held low with  $\overline{RAS}$  and  $\overline{CAS}$  high at the rising edge of the clock. While CKE is low.
- 2) Clock must be stable before exited deep power down mode.
- 3) Device must be in the all banks idle state prior to entering Deep Power Down mode.

### TO EXIT DEEP POWER DOWN MODE

- 4) The deep power down mode is exited by asserting CKE high.
- 5) 200µs wait time is required to exit from Deep Power Down.
- 6) Upon exiting deep power down an all bank precharge command must be issued followed by two auto refresh commands and a load mode register sequence.

### Self Refresh Entry & Exit Cycle



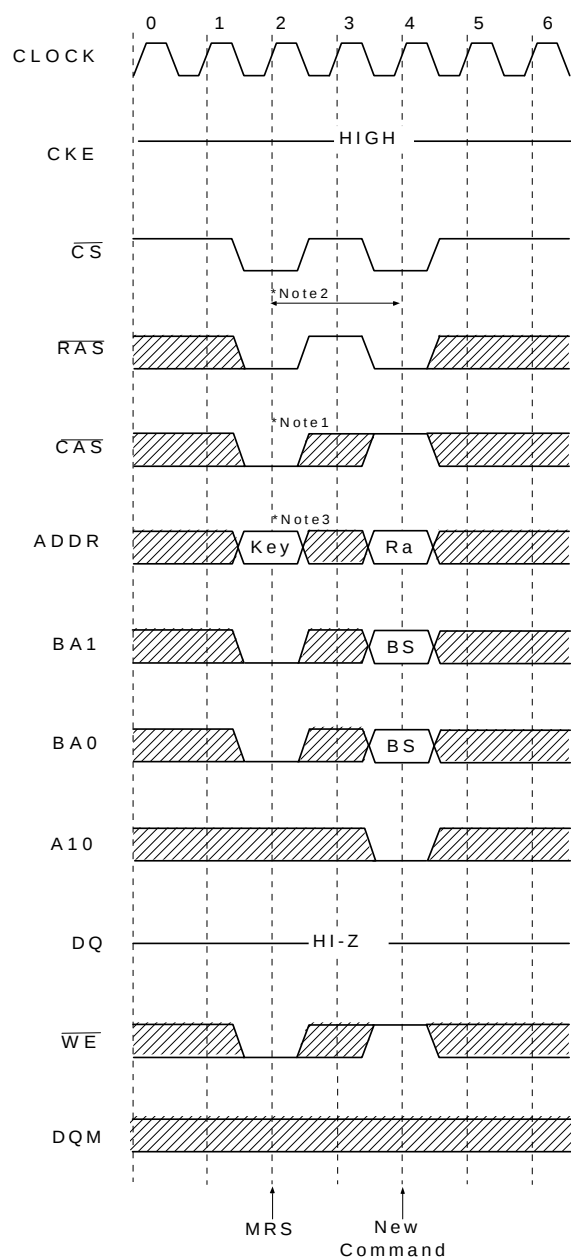
**\*Note: TO ENTER SELF REFRESH MODE**

1.  $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$  &  $\overline{\text{CAS}}$  with CKE should be low at the same clock cycle.
2. After 1 clock cycle, all the inputs including the system clock can be don't care except for CKE.
3. The device remains in self refresh mode as long as CKE stays "Low".  
cf.) Once the device enters self refresh mode, minimum  $t_{\text{RAS}}$  is required before exit from self refresh.

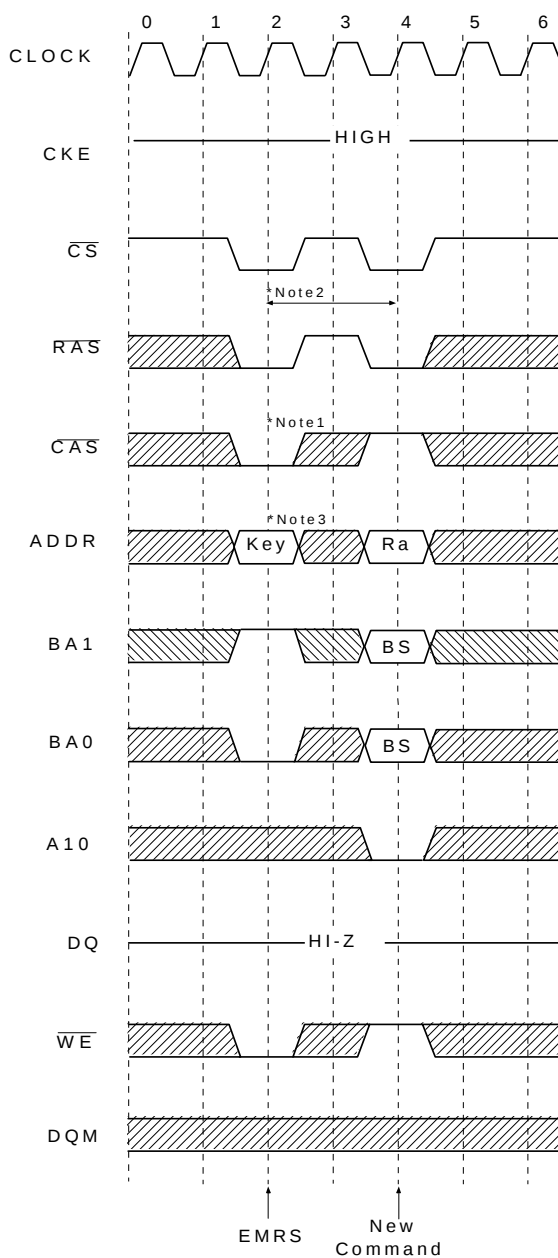
## TO EXIT SELF REFRESH MODE

4. System clock restart and be stable before returning CKE high.
5.  $\overline{\text{CS}}$  starts from high.
6. Minimum  $t_{\text{RFC}}$  is required after CKE going high to complete self refresh exit.
7. 4K cycles of burst auto refresh is required immediately before self refresh entry and immediately after self refresh exit.

## Mode Register Set Cycle



## Extended Mode Register Set Cycle



 :Don't Care

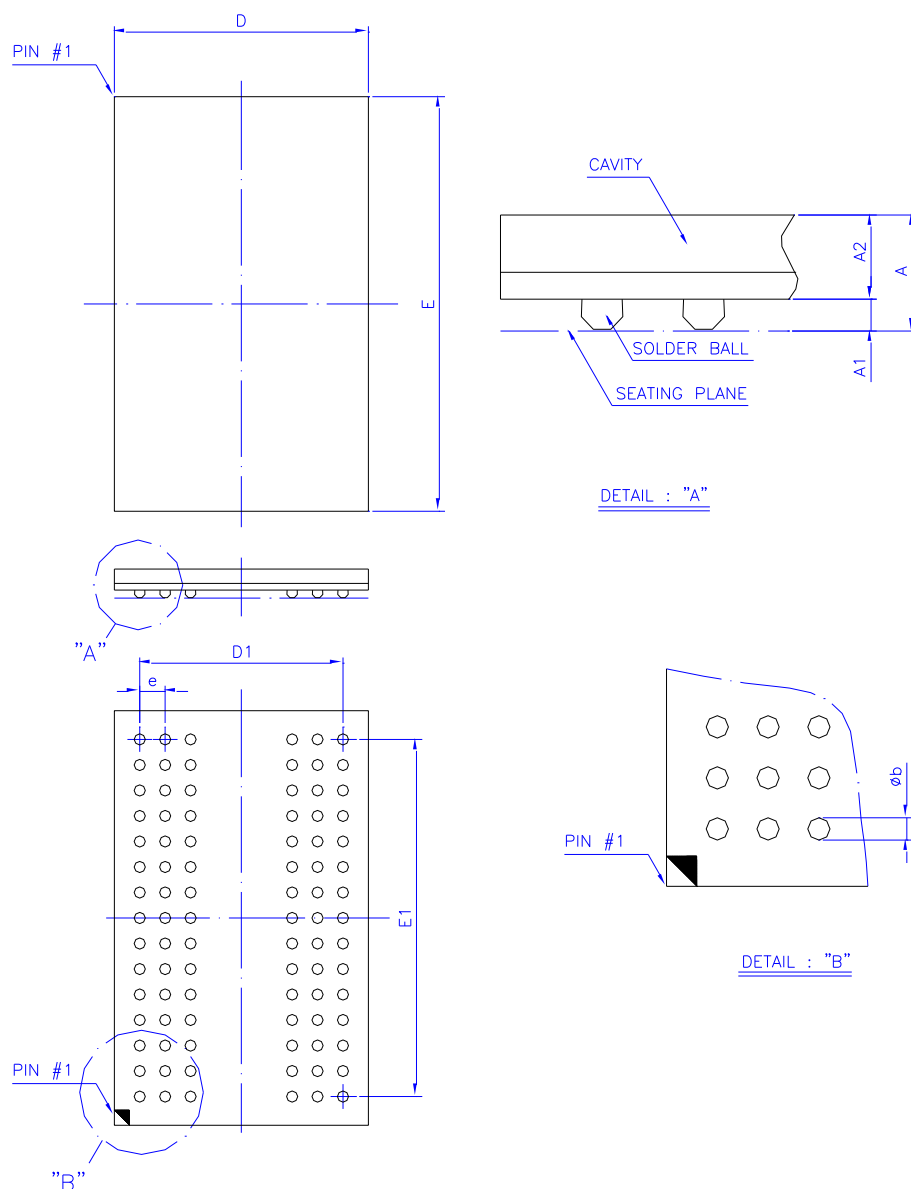
All banks precharge should be completed before Mode Register Set cycle and auto refresh cycle.

### MODE REGISTER SET CYCLE

- \*Note:
1.  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$ , &  $\overline{WE}$  activation at the same clock cycle with address key will set internal mode register.
  2. Minimum 2 clock cycles should be met before new  $\overline{RAS}$  activation.
  3. Please refer to Mode Register Set table.

## PACKING DIMENSIONS

### 90-BALL SDRAM ( 8x13 mm )



| Symbol         | Dimension in mm |       |       | Dimension in inch |       |       |
|----------------|-----------------|-------|-------|-------------------|-------|-------|
|                | Min             | Norm  | Max   | Min               | Norm  | Max   |
| A              |                 |       | 1.20  |                   |       | 0.047 |
| A <sub>1</sub> | 0.30            | 0.35  | 0.40  | 0.012             | 0.014 | 0.016 |
| A <sub>2</sub> |                 | 0.586 |       |                   | 0.023 |       |
| ø <sub>b</sub> | 0.40            | 0.45  | 0.50  | 0.016             | 0.018 | 0.020 |
| D              | 7.90            | 8.00  | 8.10  | 0.311             | 0.315 | 0.319 |
| E              | 12.90           | 13.00 | 13.10 | 0.508             | 0.512 | 0.516 |
| D <sub>1</sub> |                 | 6.40  |       |                   | 0.252 |       |
| E <sub>1</sub> |                 | 11.20 |       |                   | 0.441 |       |
| e              |                 | 0.80  |       |                   | 0.031 |       |

Controlling dimension : Millimeter.

**Revision History**

| Revision | Date       | Description                                                                                                                                |
|----------|------------|--------------------------------------------------------------------------------------------------------------------------------------------|
| 0.1      | 2011.11.24 | Original                                                                                                                                   |
| 0.2      | 2012.06.22 | 1. Delete CAS Latency: 2<br>2. Correct the figure of Deep Power Down Mode Entry & Exit Cycle                                               |
| 1.0      | 2014.02.21 | 1. Delete "Preliminary"<br>2. Modify the specification of I <sub>CC2NS</sub> , I <sub>CC3P</sub> , I <sub>CC3PS</sub> , I <sub>CC3NS</sub> |

### **Important Notice**

All rights reserved.

No part of this document may be reproduced or duplicated in any form or by any means without the prior permission of ESMT.

The contents contained in this document are believed to be accurate at the time of publication. ESMT assumes no responsibility for any error in this document, and reserves the right to change the products or specification in this document without notice.

The information contained herein is presented only as a guide or examples for the application of our products. No responsibility is assumed by ESMT for any infringement of patents, copyrights, or other intellectual property rights of third parties which may result from its use. No license, either express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of ESMT or others.

Any semiconductor devices may have inherently a certain rate of failure. To minimize risks associated with customer's application, adequate design and operating safeguards against injury, damage, or loss from such failure, should be provided by the customer when making application designs.

ESMT's products are not authorized for use in critical applications such as, but not limited to, life support devices or system, where failure or abnormal operation may directly affect human lives or cause physical injury or property damage. If products described here are to be used for such kinds of application, purchaser must do its own quality assurance testing appropriate to such applications.